

# Generative models for segmentation II

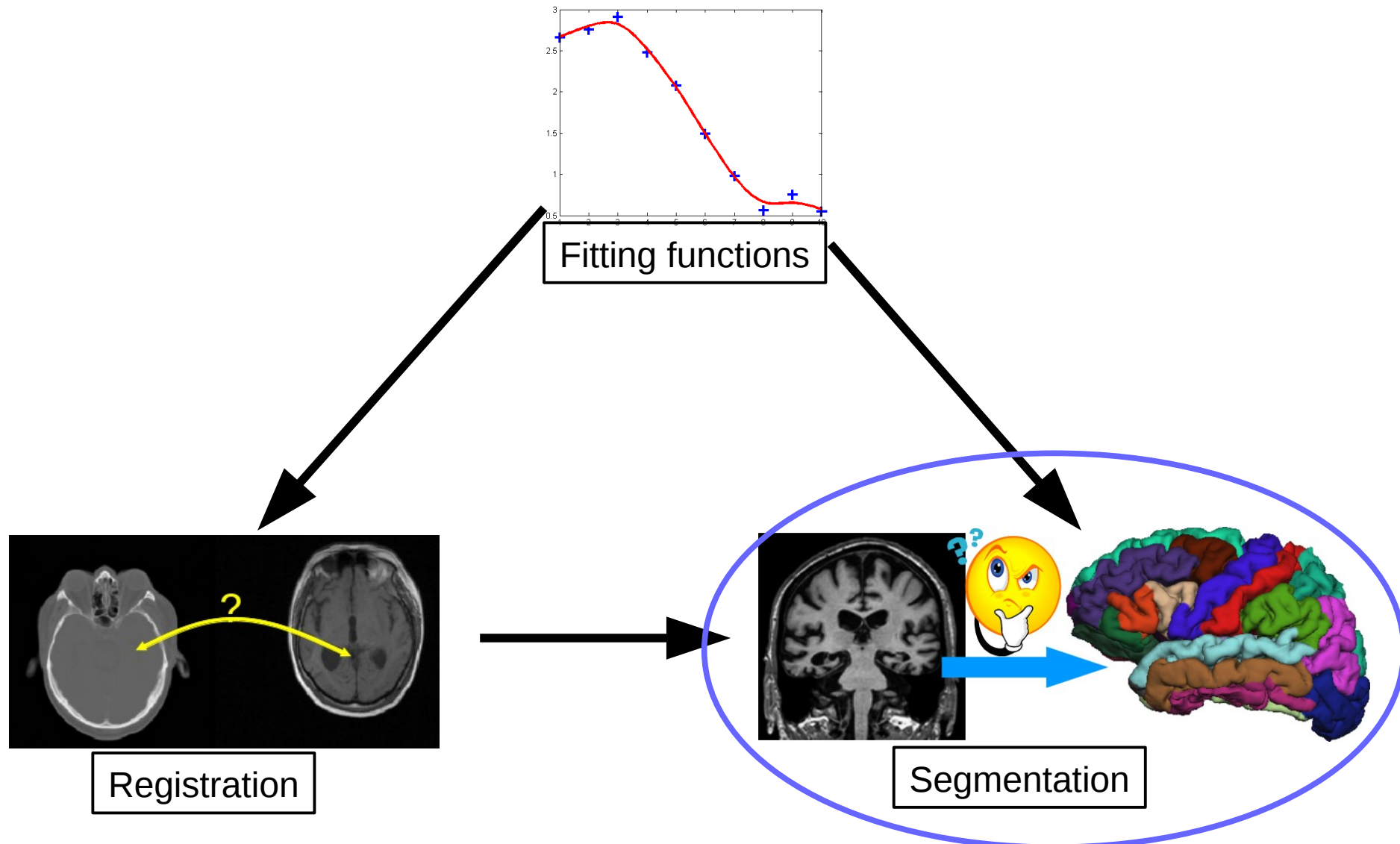
Course 22525

**Koen Van Leemput**

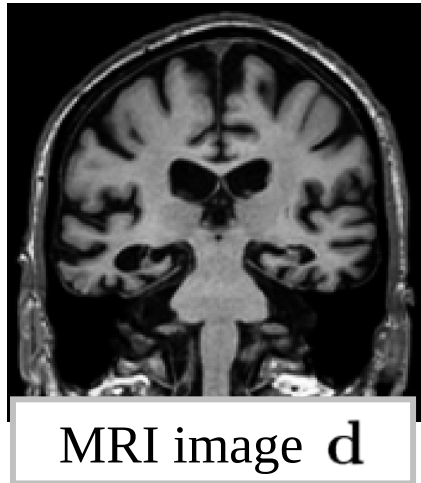
DTU HealthTech

Technical University of Denmark

# Course structure



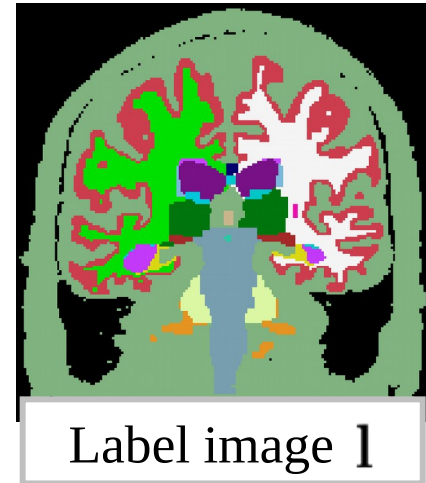
# The problem to be solved



$N$  voxels

$$\mathbf{d} = (d_1, \dots, d_N)^T$$

$d_n$ : intensity in voxel  $n$



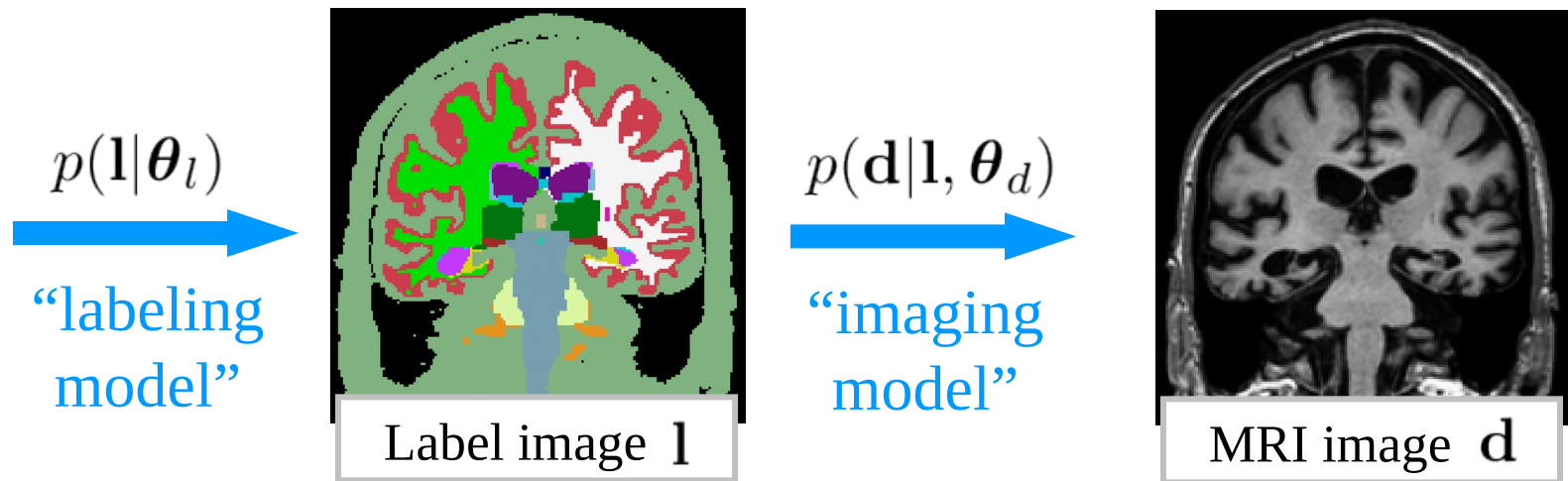
$$\mathbf{l} = (l_1, \dots, l_N)^T$$

$$l_n \in \{1, \dots, K\}$$

$K$ : number of classes

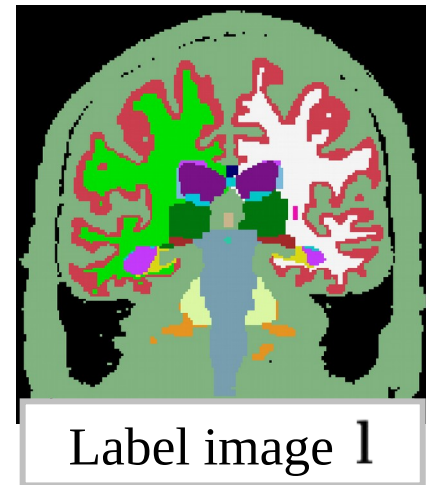
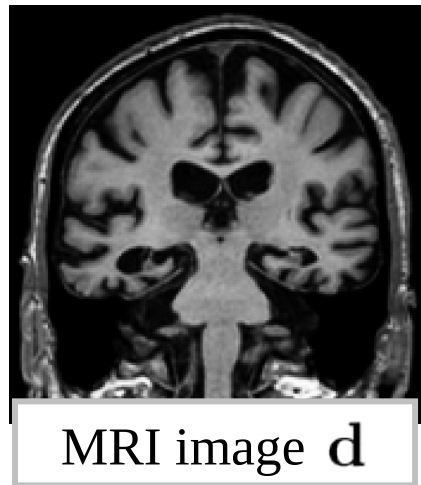
# One solution: generative modeling

- Formulate a statistical model of image formation

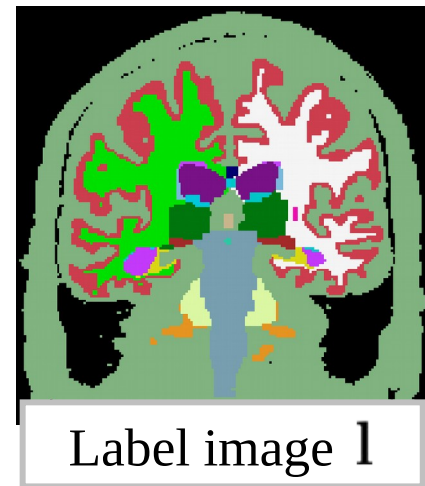
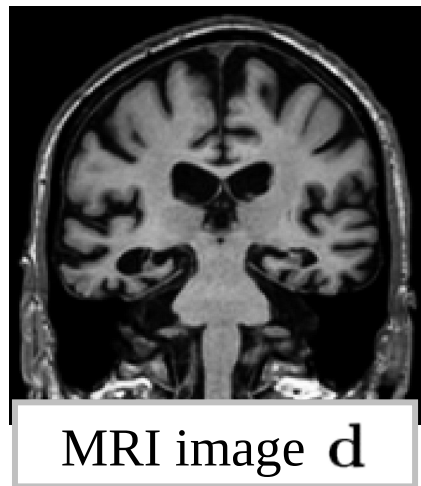


- The model depends on some parameters  $\boldsymbol{\theta} = (\boldsymbol{\theta}_l^T, \boldsymbol{\theta}_d^T)^T$

# Segmentation = inverse problem



# Segmentation = inverse problem

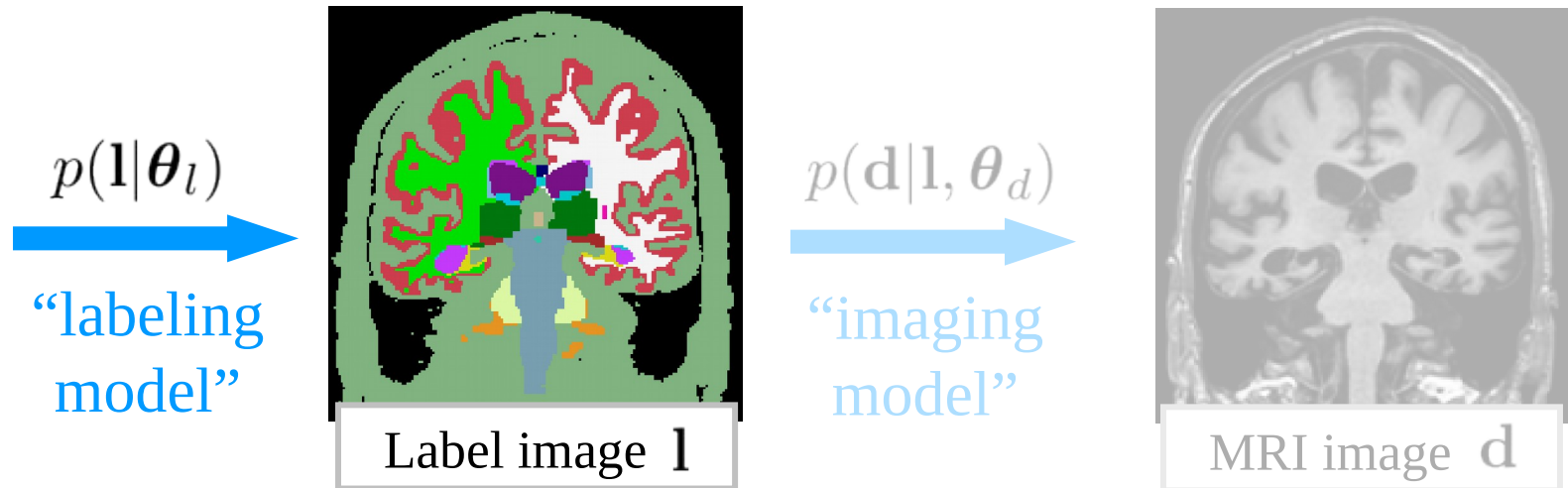


$$\hat{\mathbf{l}} = \arg \max_{\mathbf{l}} p(\mathbf{l} | \mathbf{d}, \boldsymbol{\theta})$$

## Bayesian inference

- Play with the mathematical rules of probability

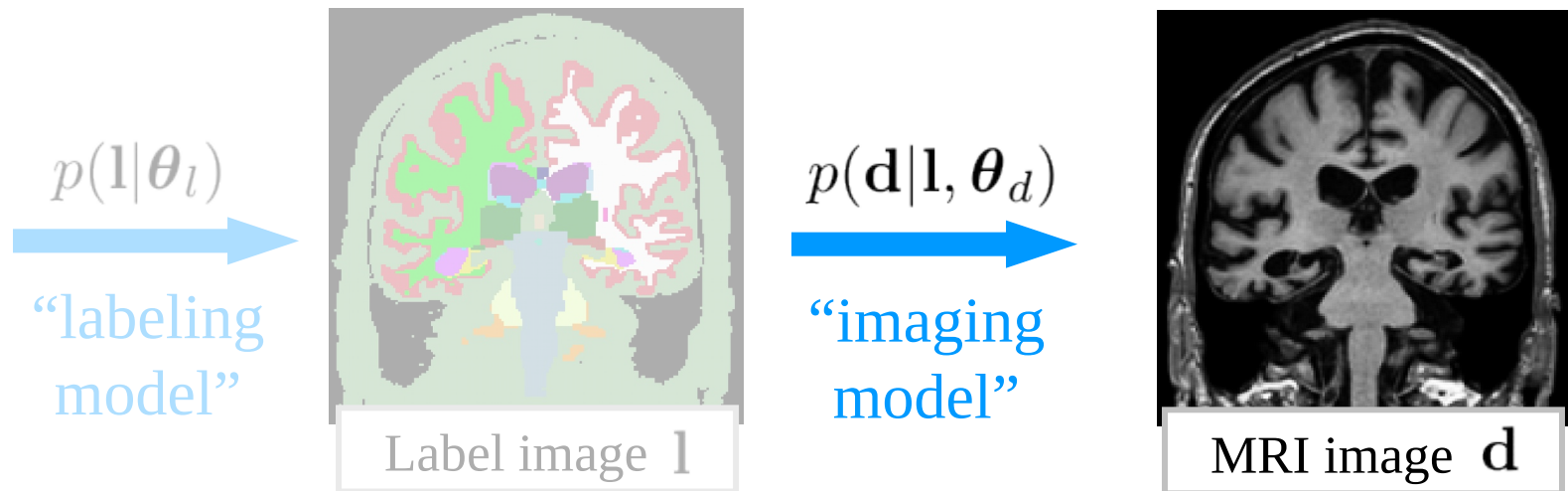
# Gaussian mixture model



- Assign a label to each voxel independently
- Probability of assigning label  $k$  is  $\pi_k$

$$p(\mathbf{l}|\boldsymbol{\theta}_l) = \prod_n \pi_{l_n} , \quad \boldsymbol{\theta}_l = (\pi_1, \dots, \pi_K)^T$$

# Gaussian mixture model



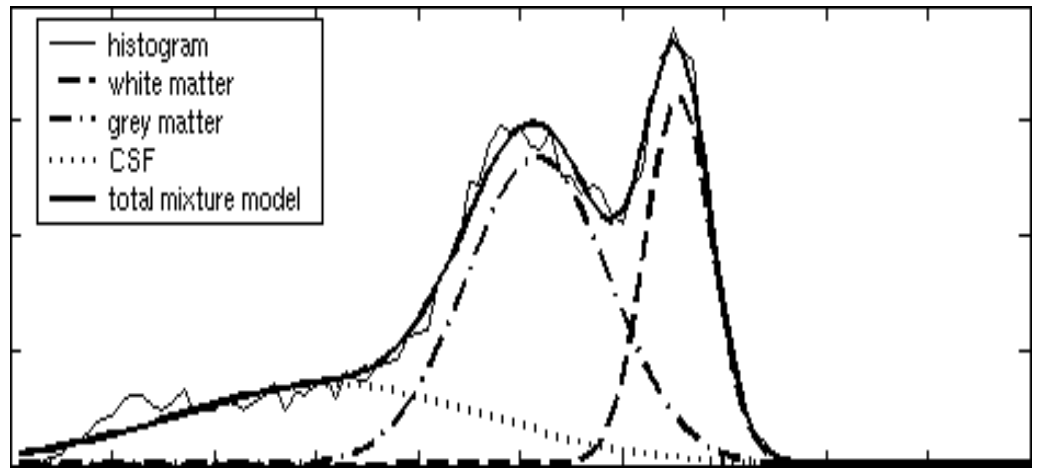
- Drawn the intensity in each voxel with label  $k$  from a Gaussian distribution with mean  $\mu_k$  and variance  $\sigma_k^2$

$$p(\mathbf{d}|\mathbf{l}, \boldsymbol{\theta}_d) = \prod_n \mathcal{N}(d_n | \mu_{l_n}, \sigma_{l_n}^2), \quad \boldsymbol{\theta}_d = (\mu_1, \dots, \mu_K, \sigma_1^2, \dots, \sigma_K^2)^T$$

$$\mathcal{N}(d|\mu, \sigma^2) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp \left[ -\frac{(d - \mu)^2}{2\sigma^2} \right]$$



# Gaussian mixture model

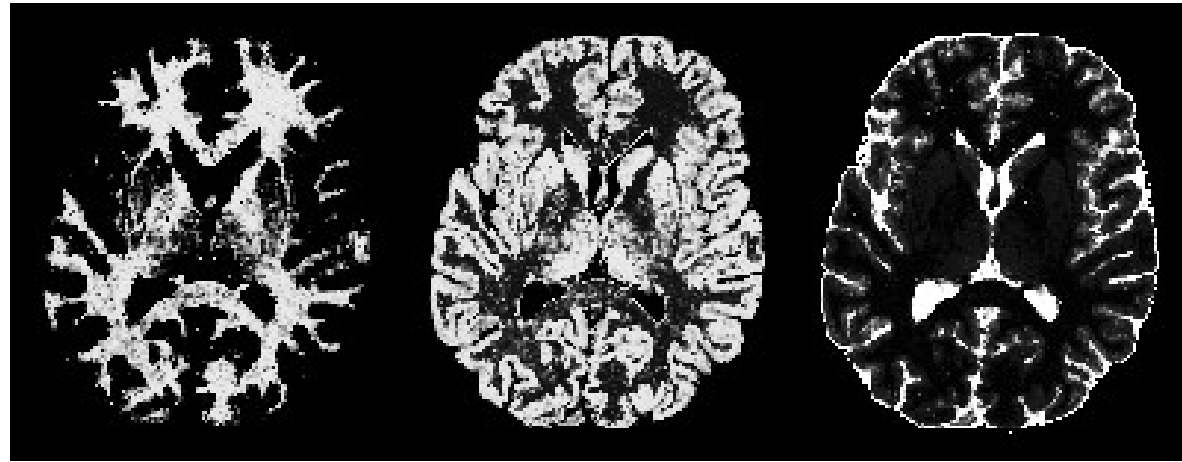


$K = 3$  labels

$$p(\mathbf{d}|\boldsymbol{\theta}) = \prod_n \left( \sum_k \mathcal{N}(d_n|\mu_k, \sigma_k^2) \pi_k \right)$$

$$\boldsymbol{\theta} = (\mu_1, \dots, \mu_K, \sigma_1^2, \dots, \sigma_K^2, \pi_1, \dots, \pi_K)^T$$

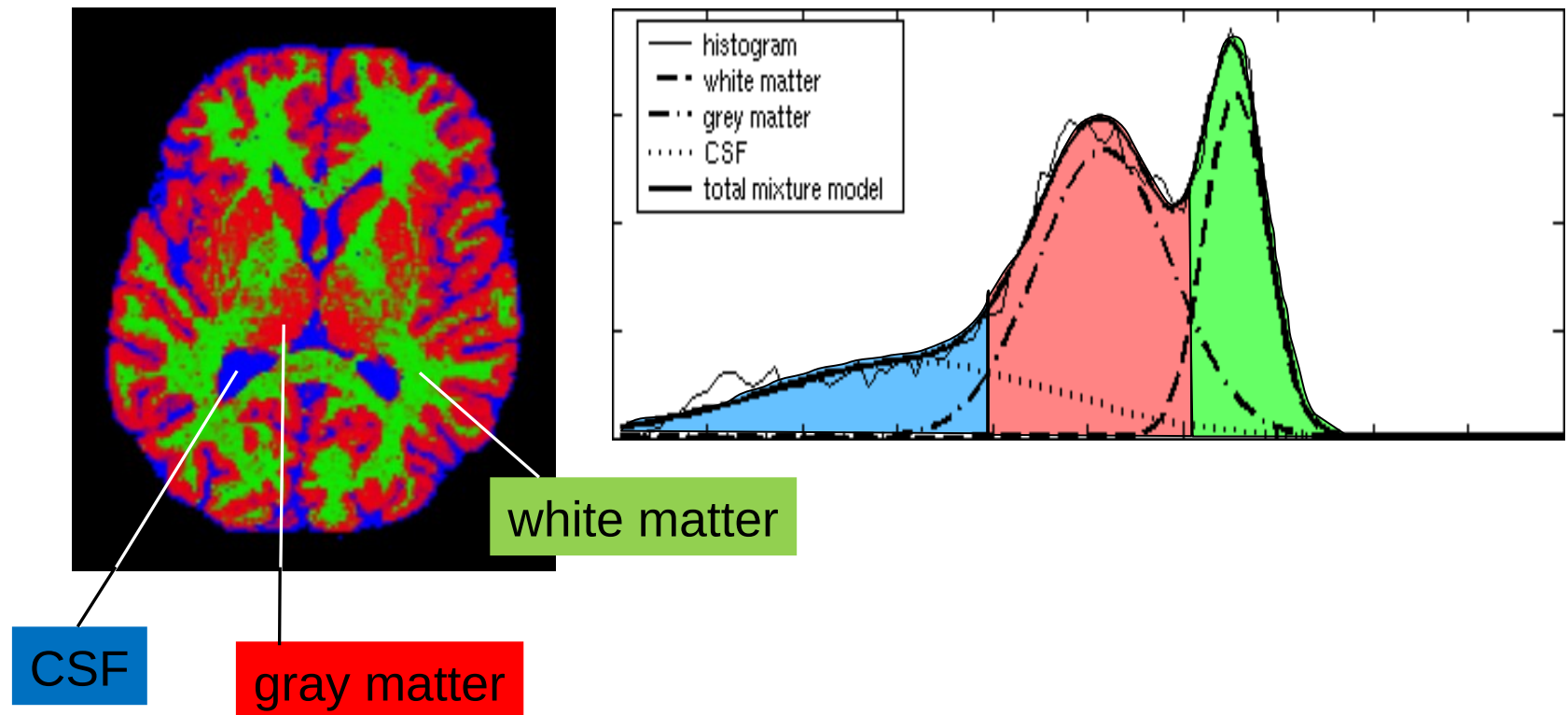
# Gaussian mixture model



- Apply Bayes' rule:  $p(\mathbf{l}|\mathbf{d}, \boldsymbol{\theta}) = \prod_n p(l_n|d_n, \boldsymbol{\theta})$

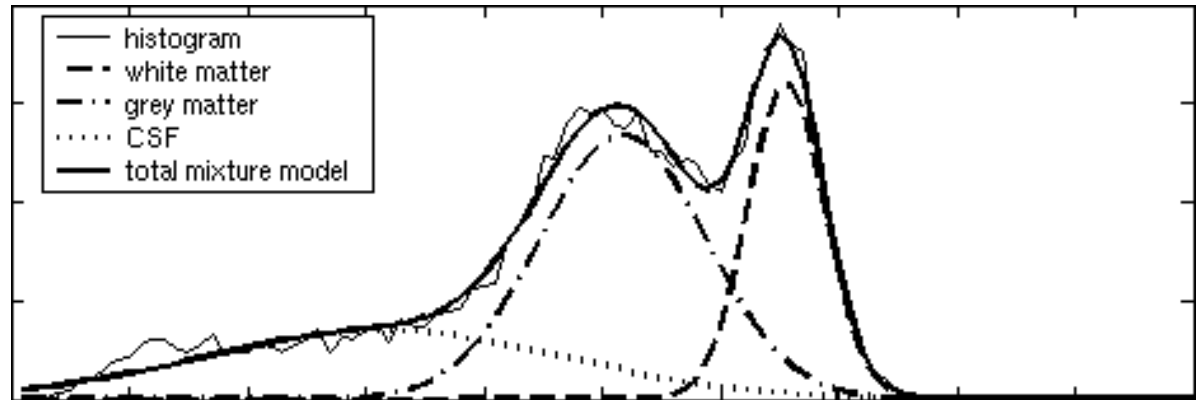
$$p(l_n|d_n, \boldsymbol{\theta}) \propto \mathcal{N}(d_n|\mu_{l_n}, \sigma_{l_n}^2) \pi_{l_n}$$

# Gaussian mixture model



$$\hat{l} = \arg \max_l p(l|\mathbf{d}, \boldsymbol{\theta}) = \arg \max_{l_1, \dots, l_N} p(l_n | d_n, \boldsymbol{\theta})$$

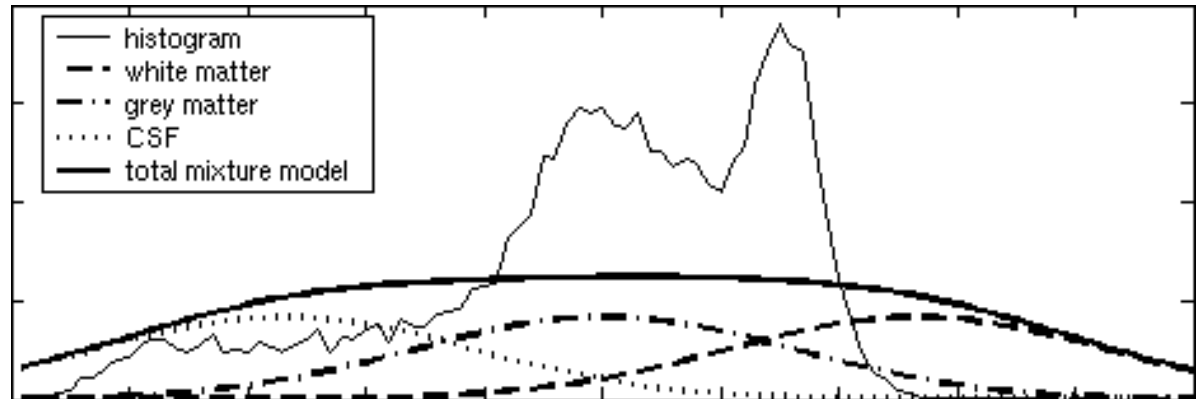
# Today's lecture



How to obtain  $\theta = (\mu_1, \dots, \mu_K, \sigma_1^2, \dots, \sigma_K^2, \pi_1, \dots, \pi_K)^T$



# Today's lecture

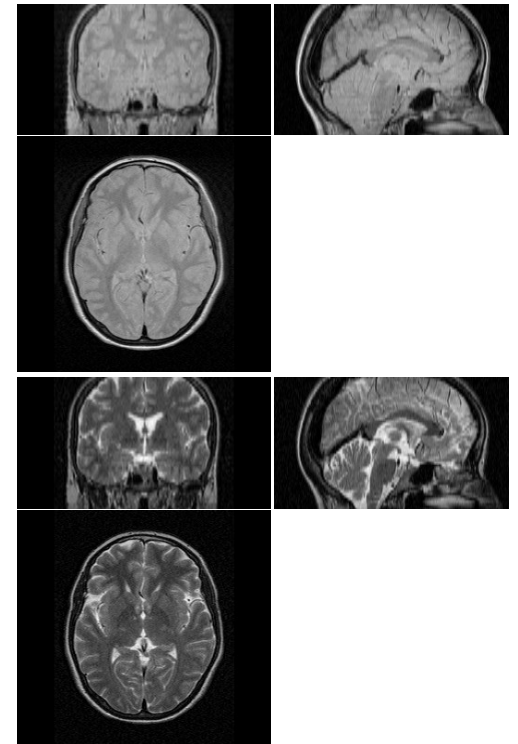


How to obtain  $\theta = (\mu_1, \dots, \mu_K, \sigma_1^2, \dots, \sigma_K^2, \pi_1, \dots, \pi_K)^T$



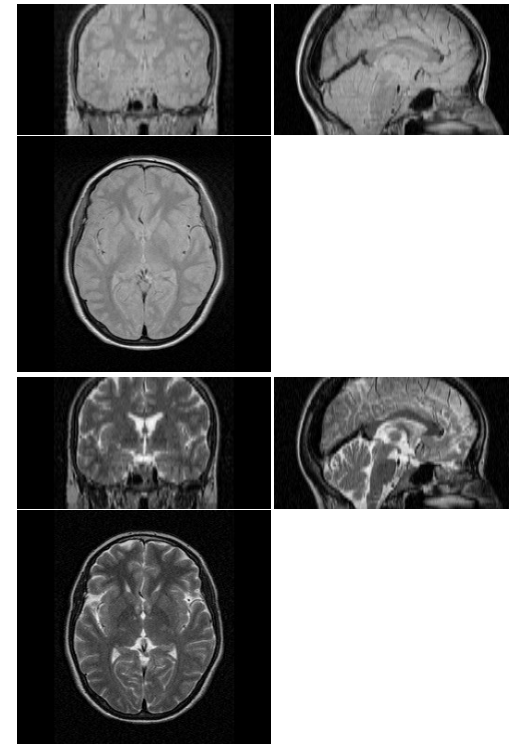
# How to obtain model parameters?

- Click manually on some representative points for each label
- “Train once, apply forever”
- Doesn't work well in MRI:
  - ✓ different imaging protocols
  - ✓ different scanner platforms (make, version)
  - ✓ software/hardware upgrades
  - ✓ ....

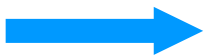


# How to obtain model parameters?

- Click manually on some representative points for each label
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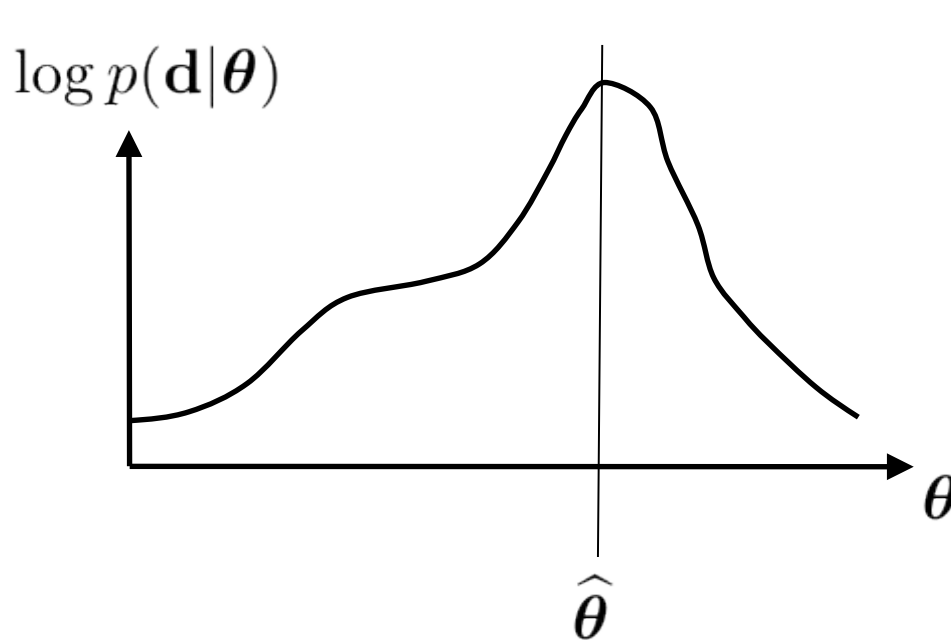


**Estimate the model parameters  
automatically from each individual  
scan**



# Parameter optimization

Estimate the *maximum likelihood* parameters:

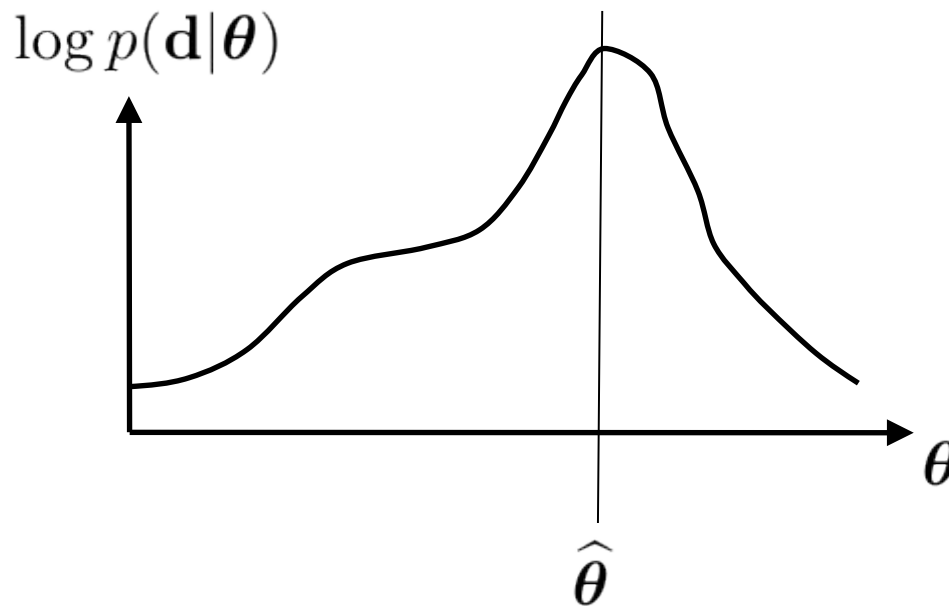


$$\begin{aligned}\hat{\boldsymbol{\theta}} &= \arg \max_{\boldsymbol{\theta}} p(\mathbf{d}|\boldsymbol{\theta}) \\ &= \arg \max_{\boldsymbol{\theta}} \log p(\mathbf{d}|\boldsymbol{\theta})\end{aligned}$$



# Parameter optimization

Estimate the *maximum likelihood* parameters:



$$\hat{\theta} = \arg \max_{\theta} p(\mathbf{d}|\theta)$$

$$\hat{\theta} = \arg \max_{\theta} \log p(\mathbf{d}|\theta)$$

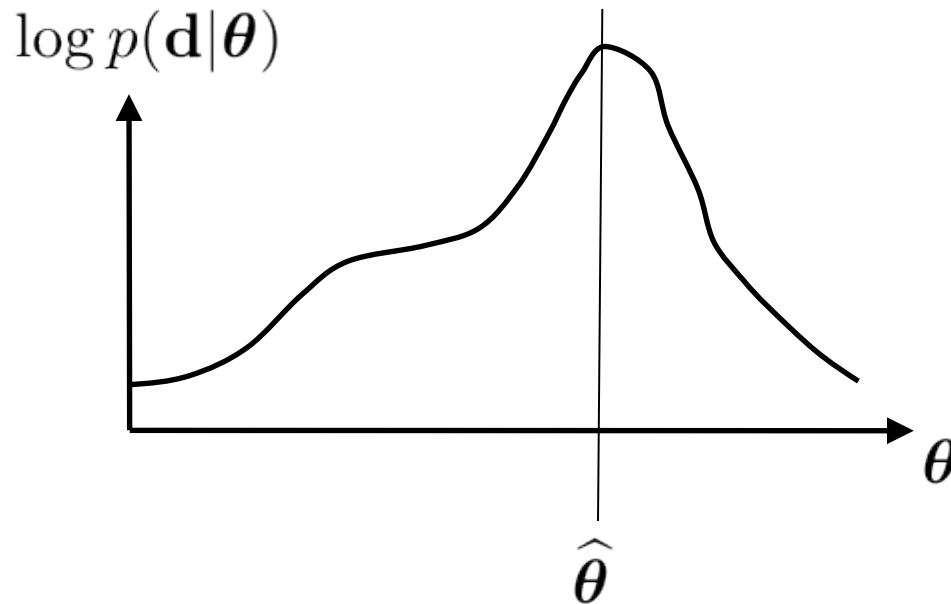
1. Is this valid - e.g., could I use `sine()` instead of `log()`?

2. Benefit? Hint: compute  $(0.01)^{1000}$  in Matlab/Python



# Parameter optimization

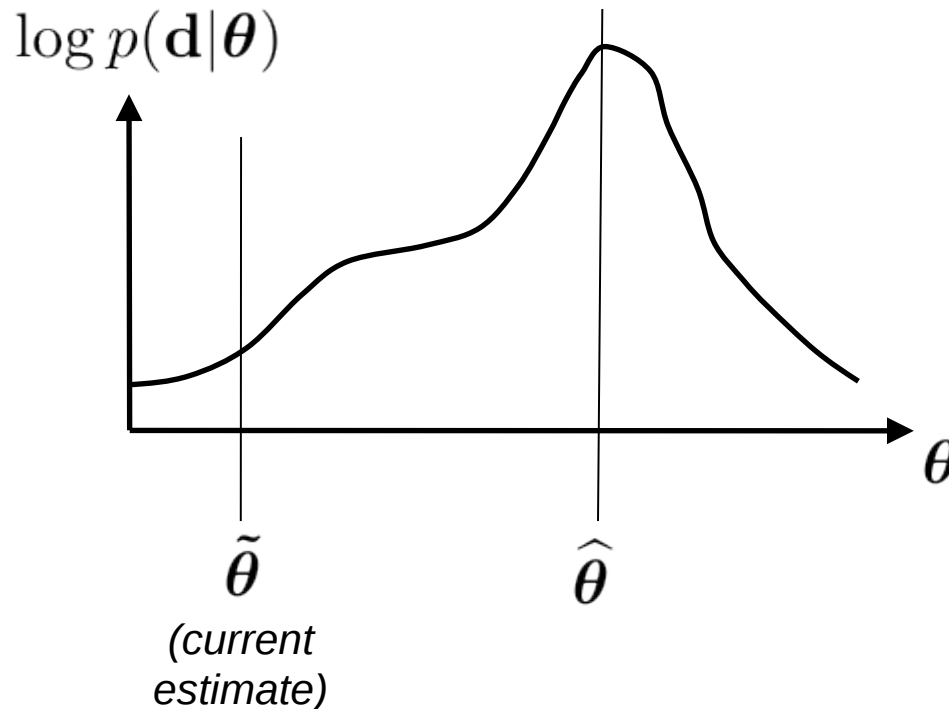
Expectation Maximization  
(EM) algorithm:



- Repeatedly maximize a lower bound to the objective function

# Parameter optimization

Expectation Maximization  
(EM) algorithm:

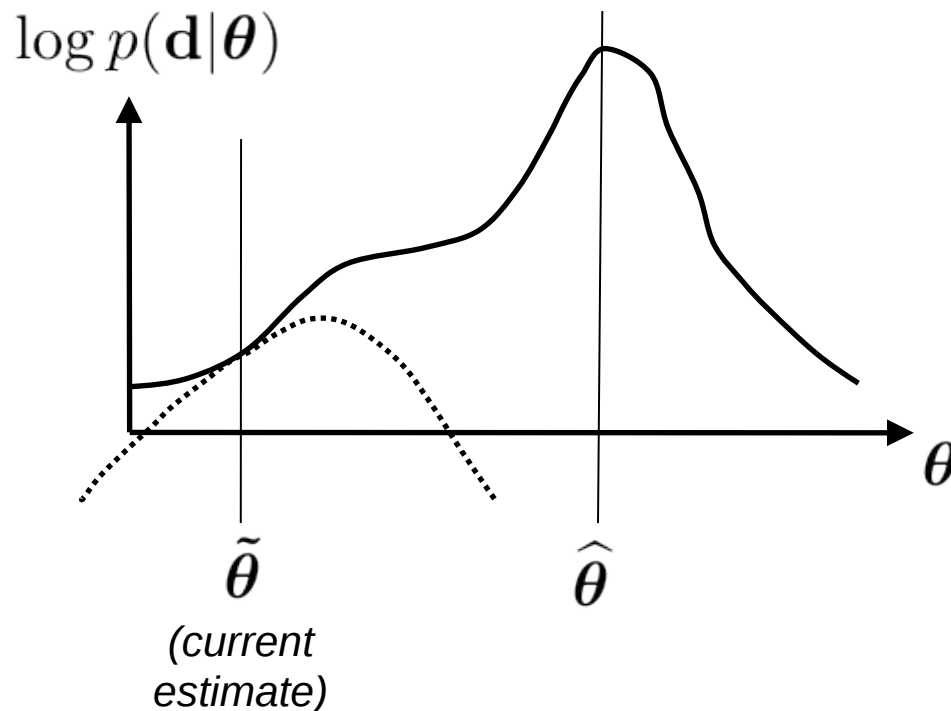


- Repeatedly maximize a lower bound to the objective function

# Parameter optimization

Expectation Maximization  
(EM) algorithm:

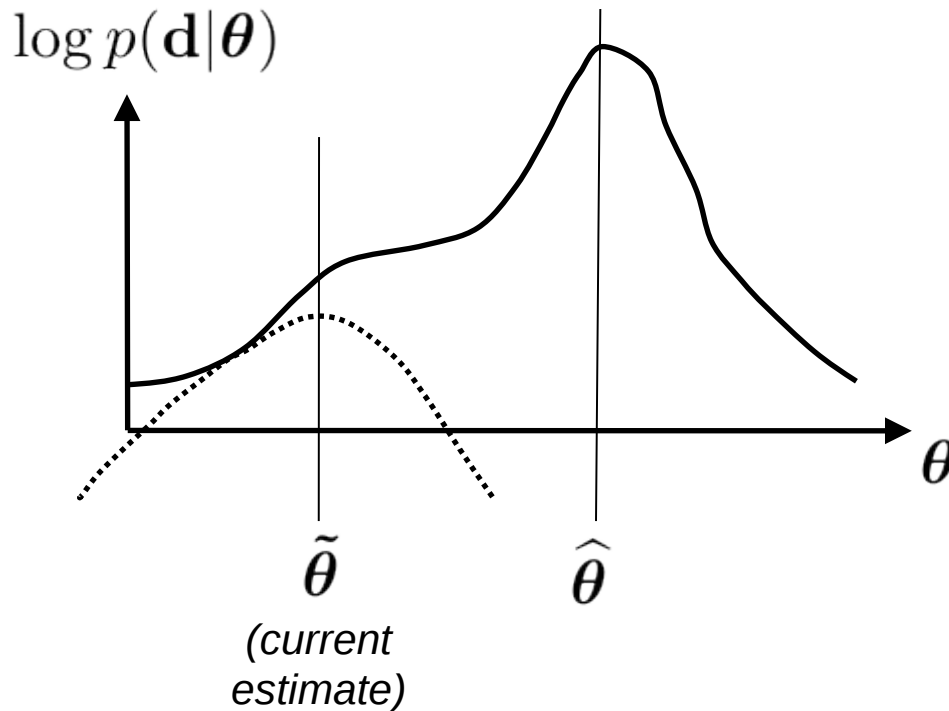
- Repeatedly maximize a lower bound to the objective function



# Parameter optimization

Expectation Maximization  
(EM) algorithm:

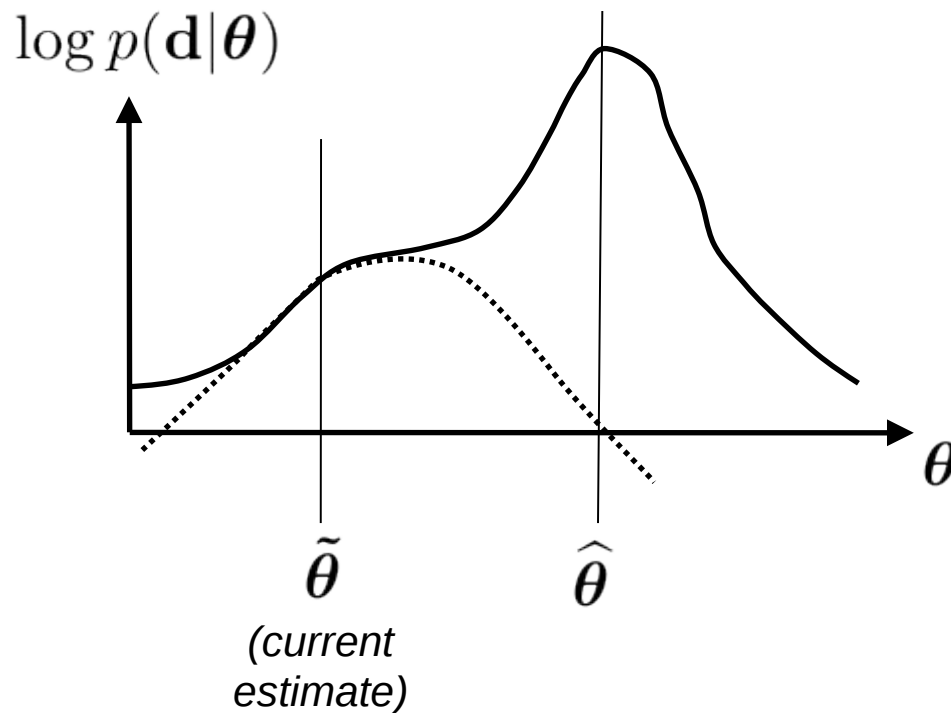
- Repeatedly maximize a lower bound to the objective function



# Parameter optimization

Expectation Maximization  
(EM) algorithm:

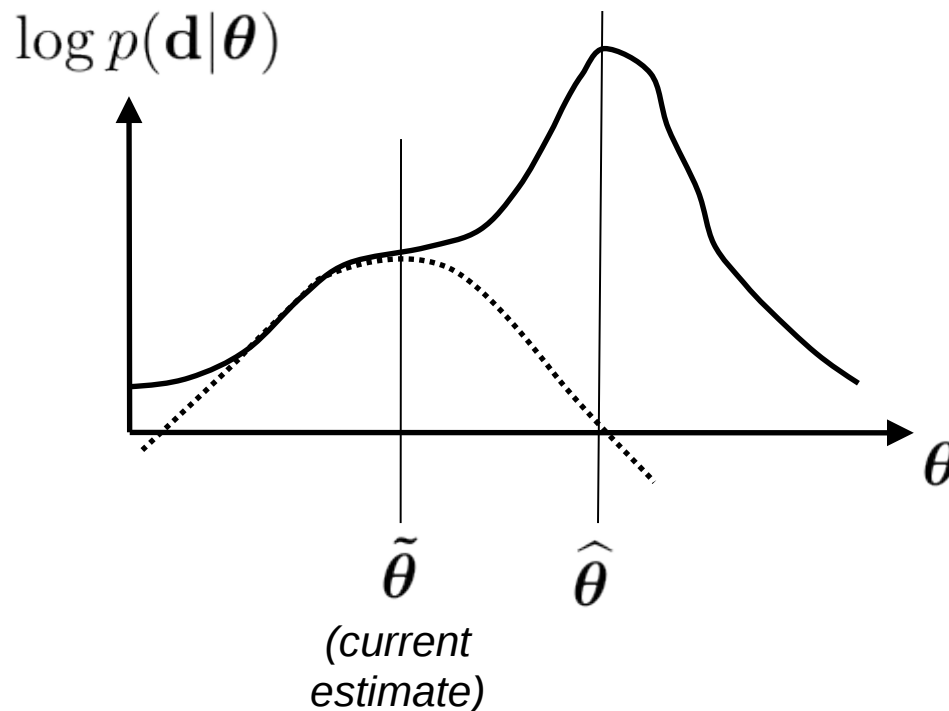
- Repeatedly maximize a lower bound to the objective function



# Parameter optimization

Expectation Maximization  
(EM) algorithm:

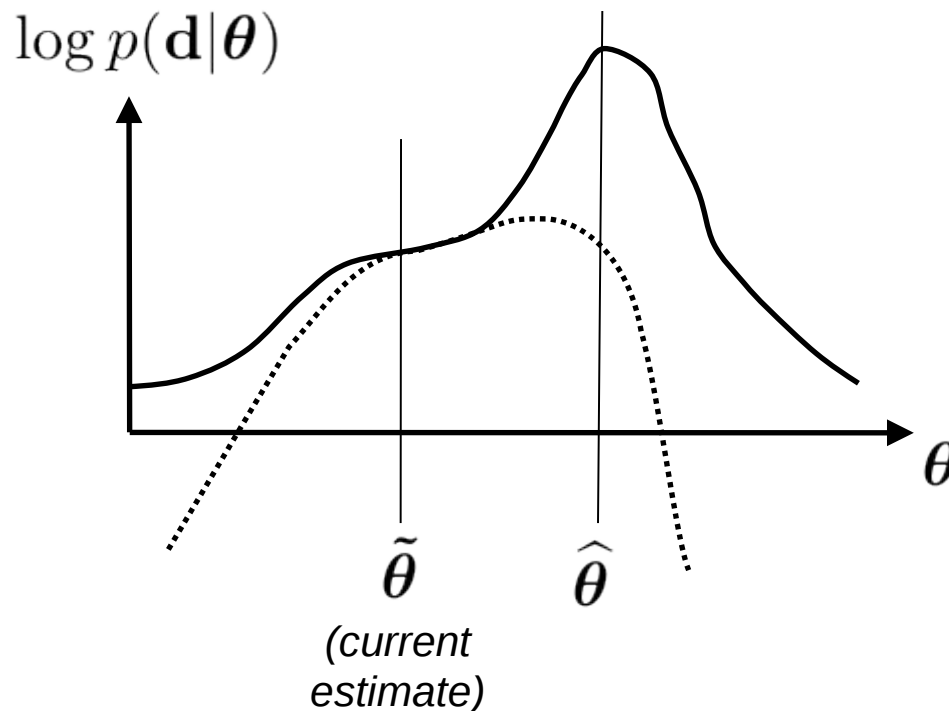
- Repeatedly maximize a lower bound to the objective function



# Parameter optimization

Expectation Maximization  
(EM) algorithm:

- Repeatedly maximize a lower bound to the objective function

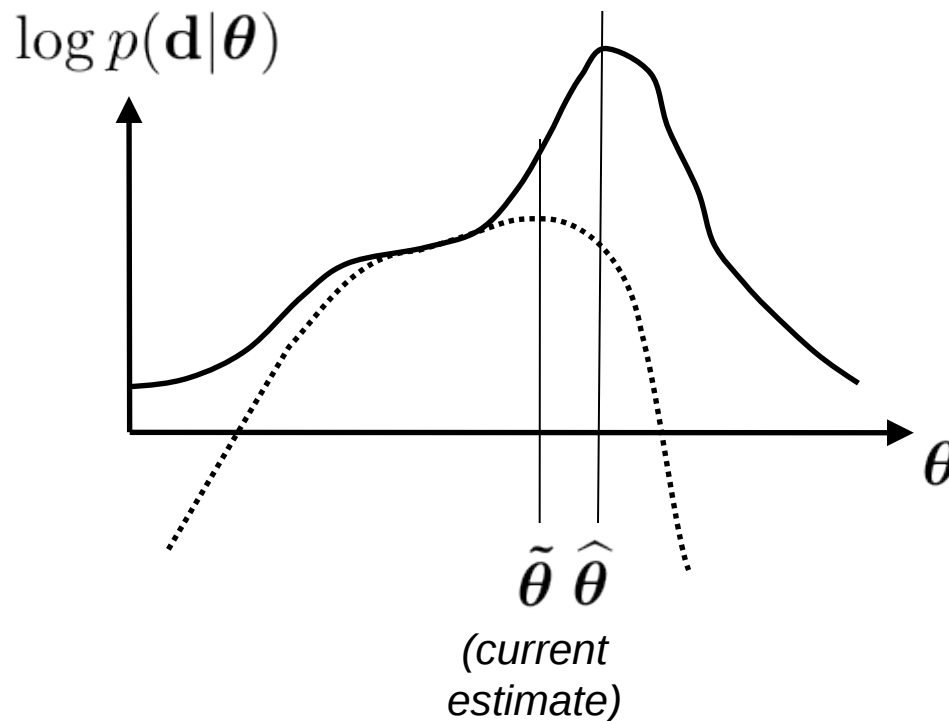




# Parameter optimization

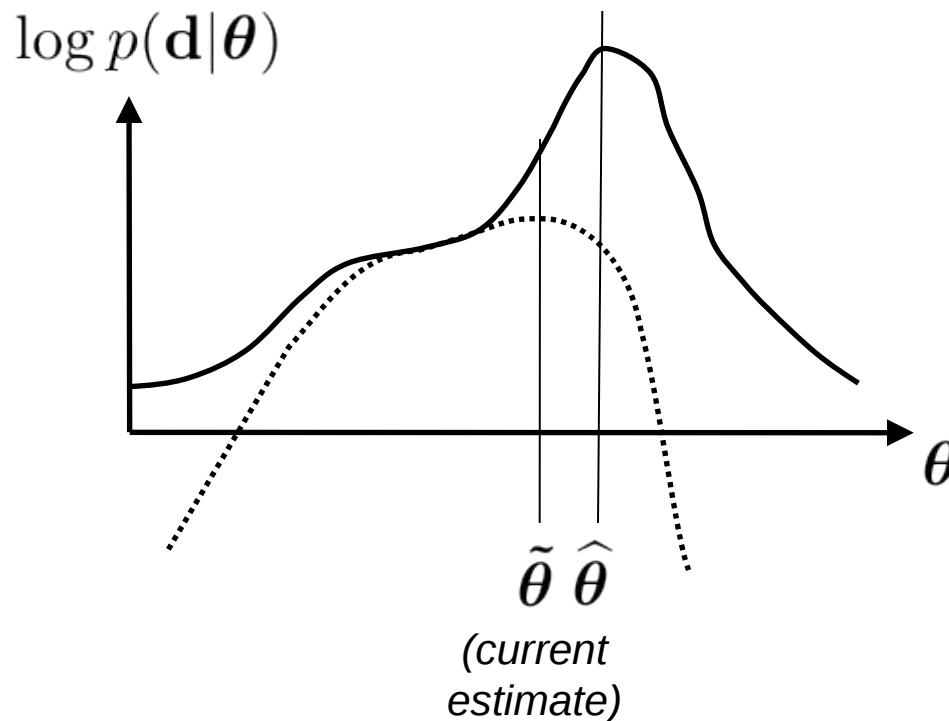
Expectation Maximization  
(EM) algorithm:

- Repeatedly maximize a lower bound to the objective function



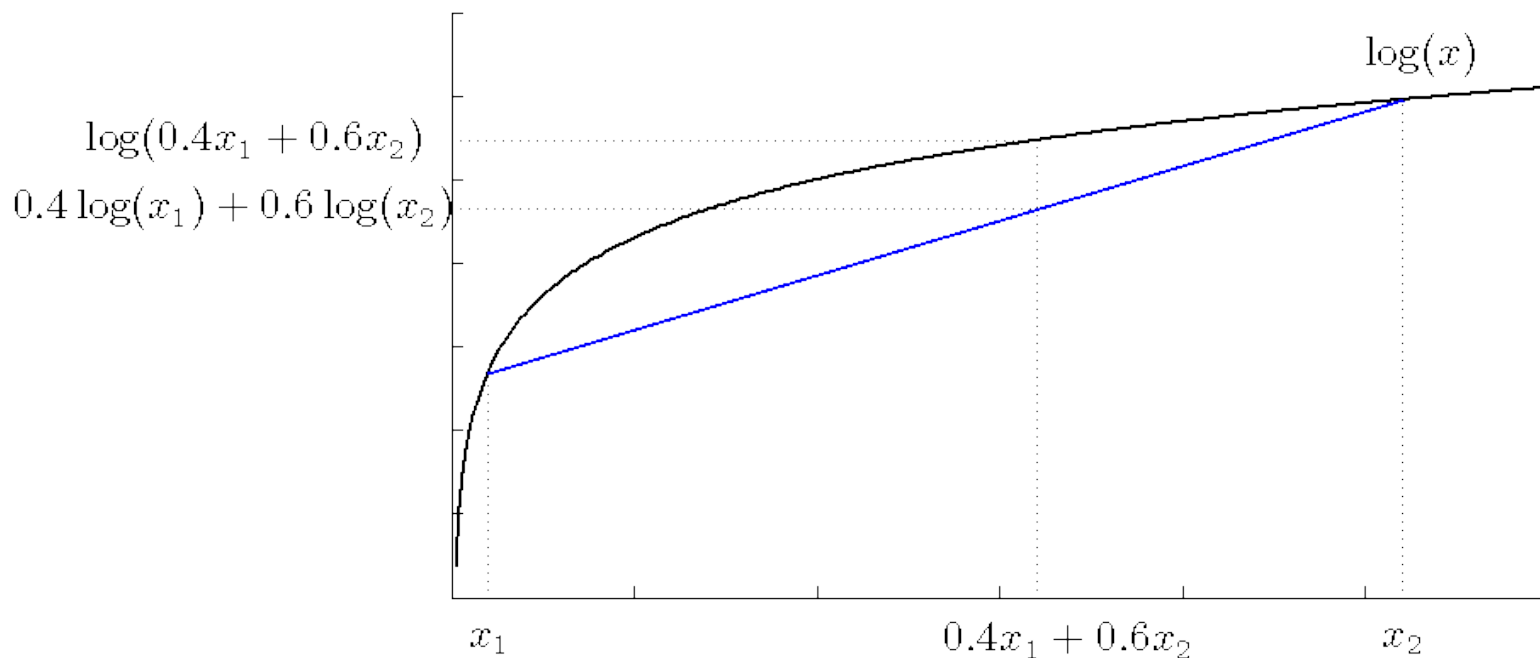
# Parameter optimization

Expectation Maximization (EM) algorithm:



- Repeatedly maximize a lower bound to the objective function
- Guaranteed to **never** move in a wrong direction!

# Constructing the lower bound

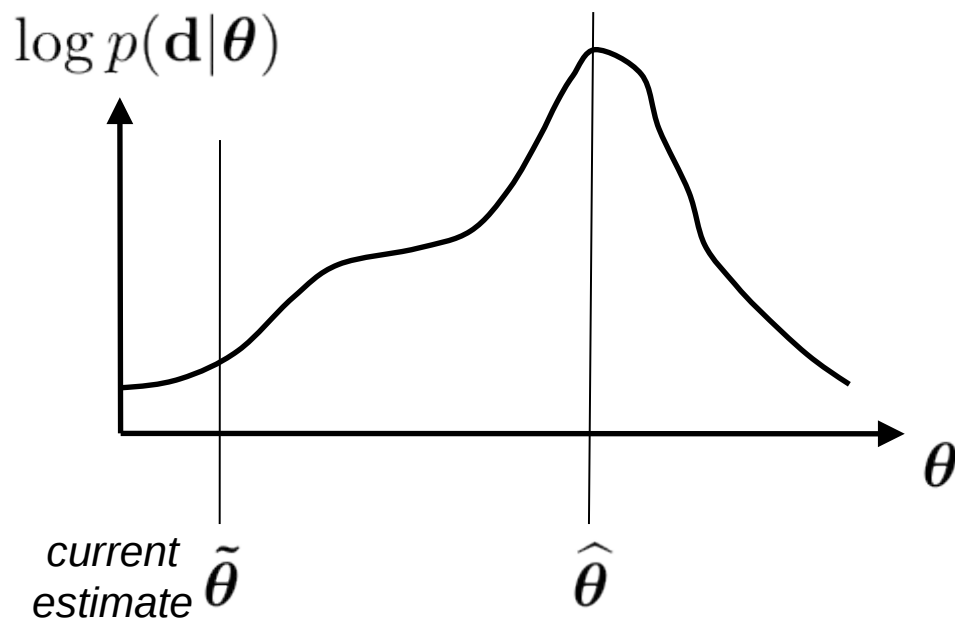


Extends easily to more  
than two variables  
(Jensen's inequality):

$$\log\left(\sum_k w_k x_k\right) \geq \sum_k w_k \log(x_k)$$
$$w_k \geq 0, \forall k \quad \text{and} \quad \sum_k w_k = 1$$

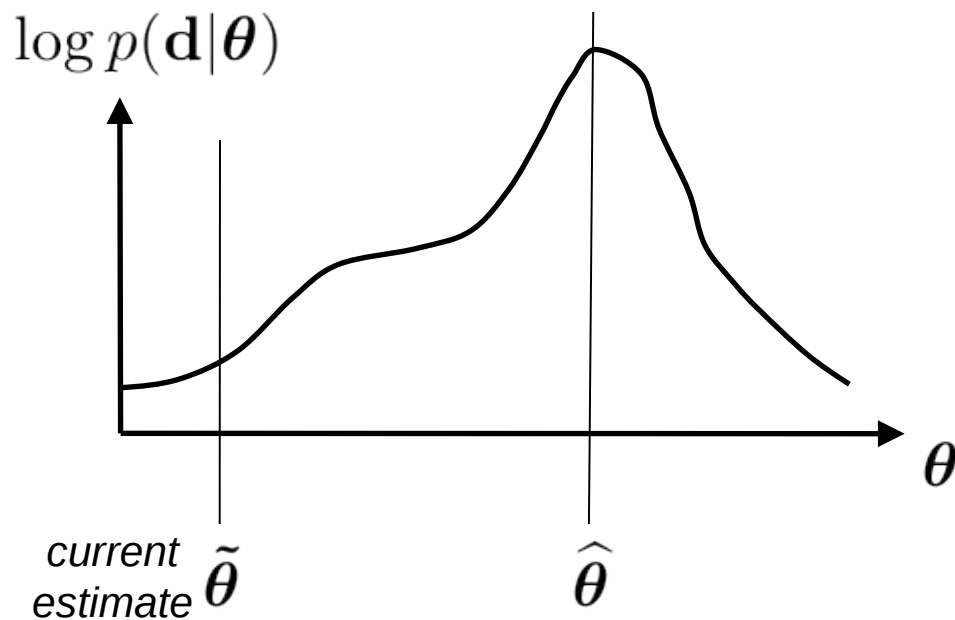
# Constructing the lower bound

$$\log p(\mathbf{d}|\boldsymbol{\theta}) = \sum_n \log \left( \sum_k \mathcal{N}(d_n|\mu_k, \sigma_k^2) \pi_k \right)$$



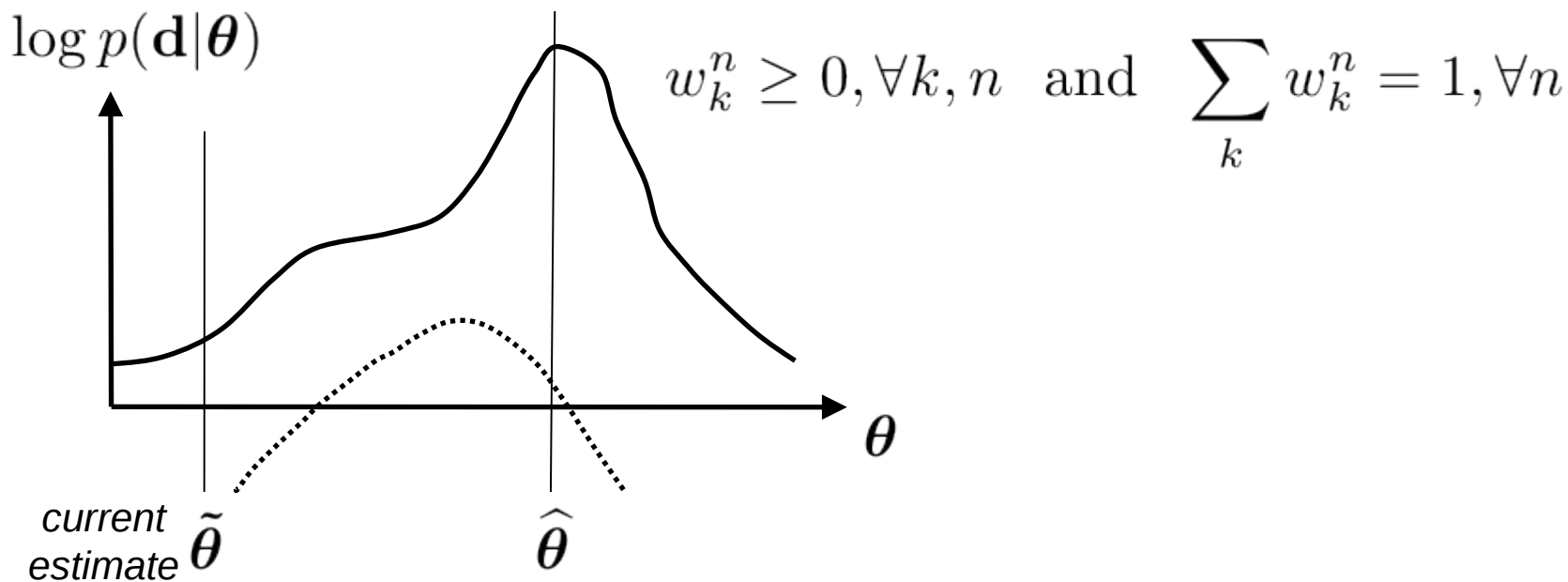
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$$\log p(\mathbf{d}|\boldsymbol{\theta}) = \sum_n \log \left( \sum_k \left[ \frac{\mathcal{N}(d_n | \mu_k, \sigma_k^2) \pi_k}{w_k^n} \right] w_k^n \right)$$



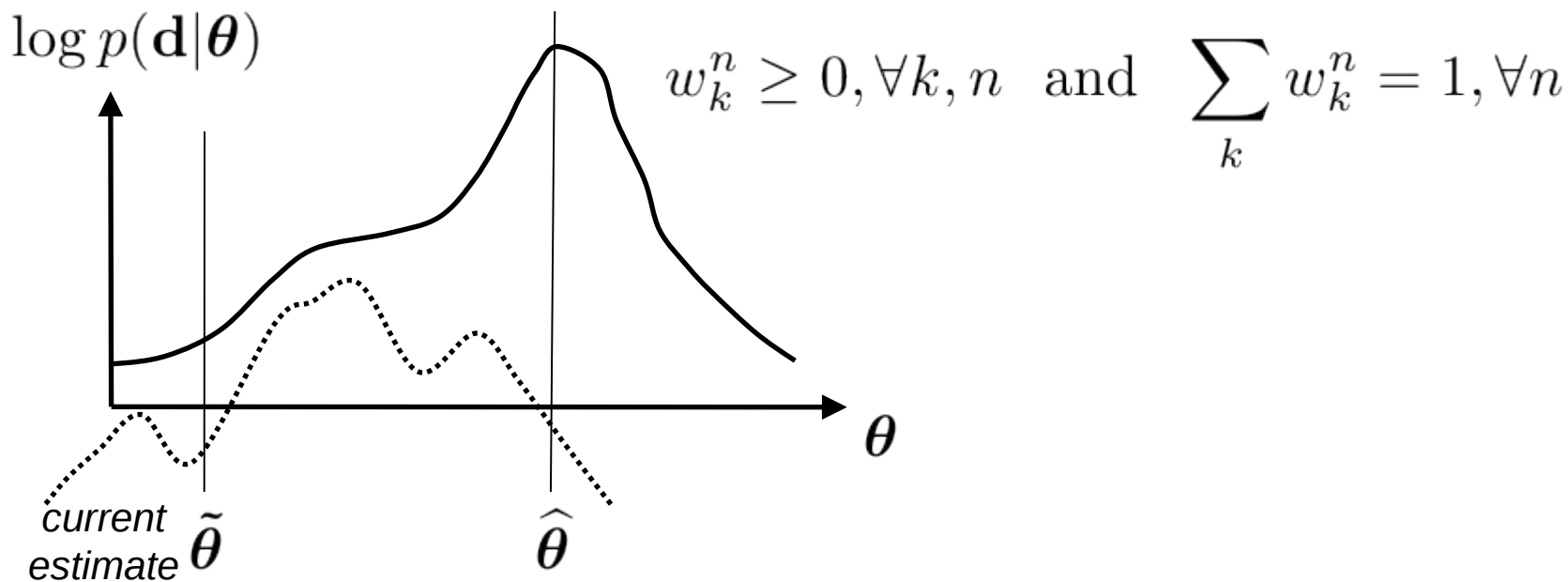
# Constructing the lower bound

$$\begin{aligned}\log p(\mathbf{d}|\boldsymbol{\theta}) &= \sum_n \log \left( \sum_k \left[ \frac{\mathcal{N}(d_n|\mu_k, \sigma_k^2) \pi_k}{w_k^n} \right] w_k^n \right) \\ &\geq \sum_n \sum_k w_k^n \log \left( \frac{\mathcal{N}(d_n|\mu_k, \sigma_k^2) \pi_k}{w_k^n} \right)\end{aligned}$$



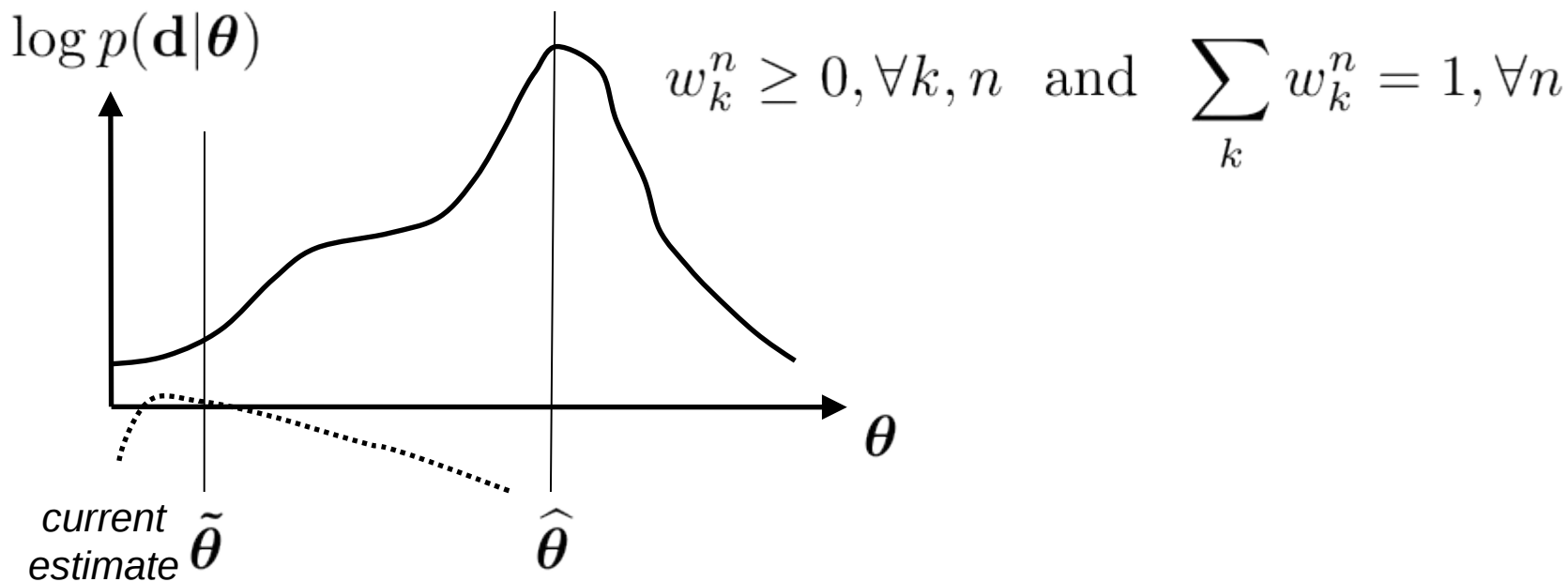
# Constructing the lower bound

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# Constructing the lower bound

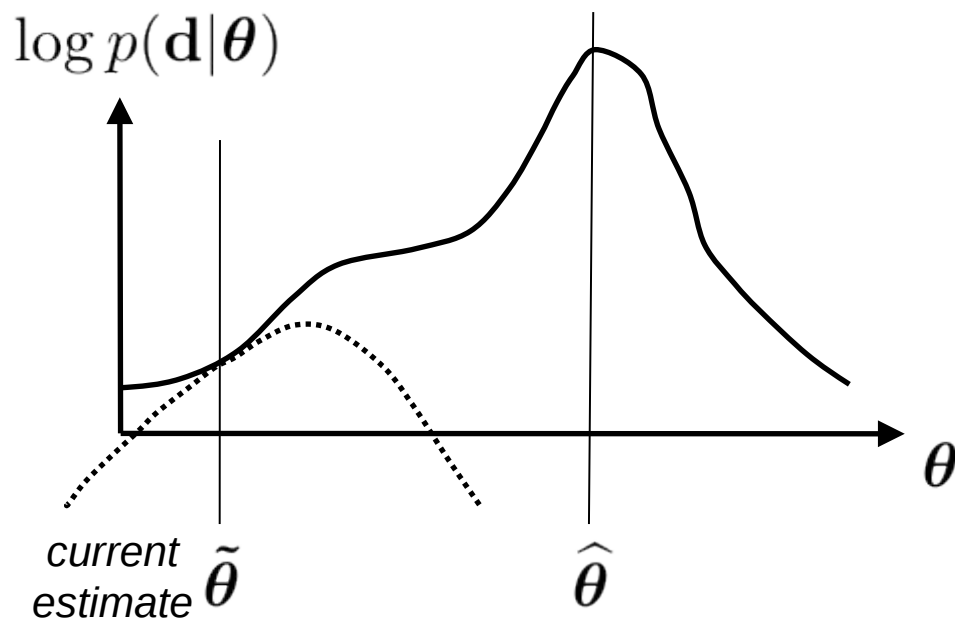
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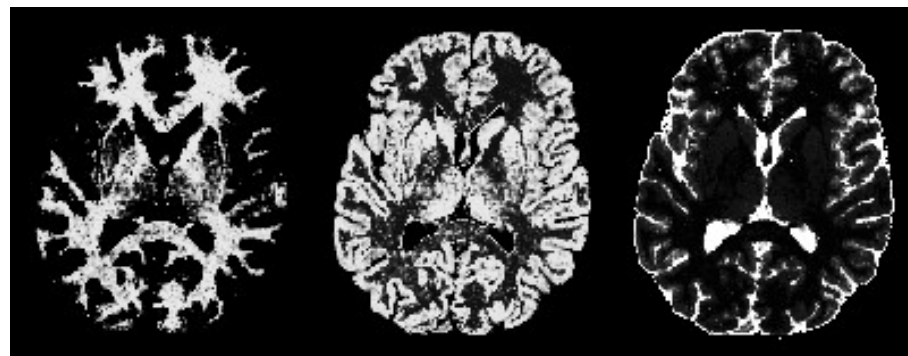
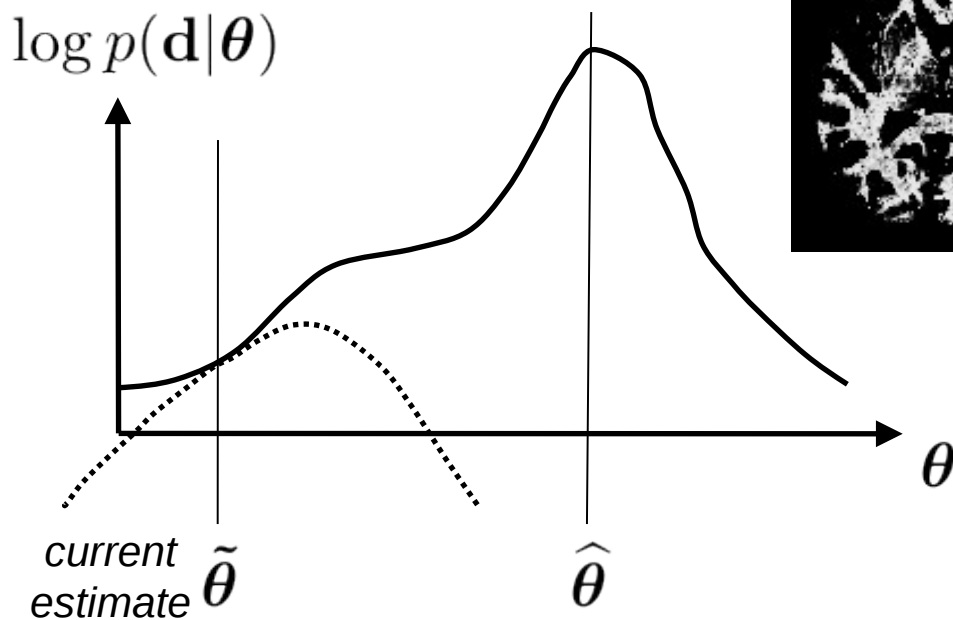
# Constructing the lower bound

The lower bound touches the objective function at the current parameter estimate if  $w_k^n \propto \mathcal{N}(d_n | \tilde{\mu}_k, \tilde{\sigma}_k^2) \tilde{\pi}_k$



# Constructing the lower bound

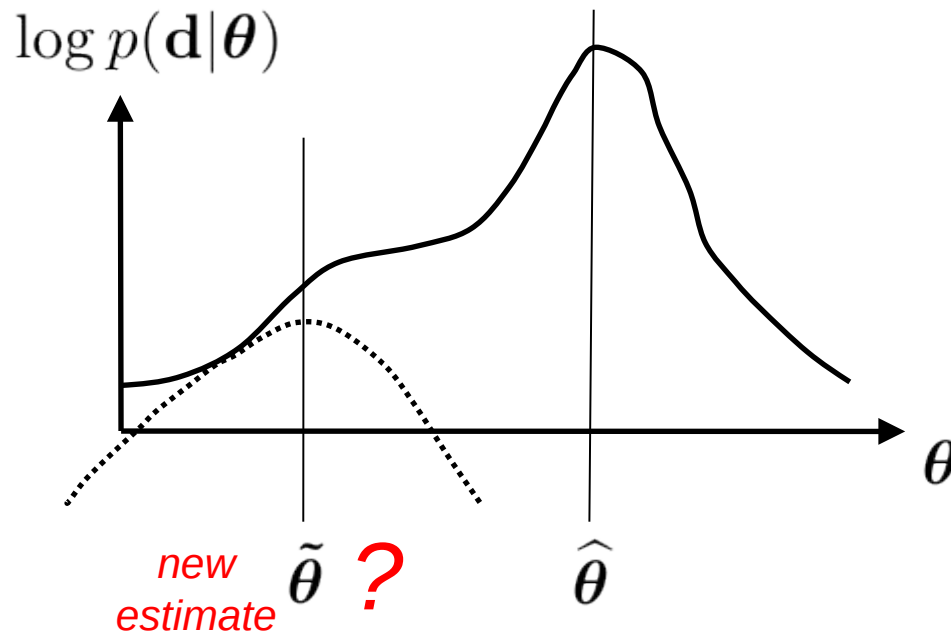
The lower bound touches the objective function at the current parameter estimate if  $w_k^n \propto \mathcal{N}(d_n | \tilde{\mu}_k, \tilde{\sigma}_k^2) \tilde{\pi}_k$



# Maximizing the lower bound

Lower bound:

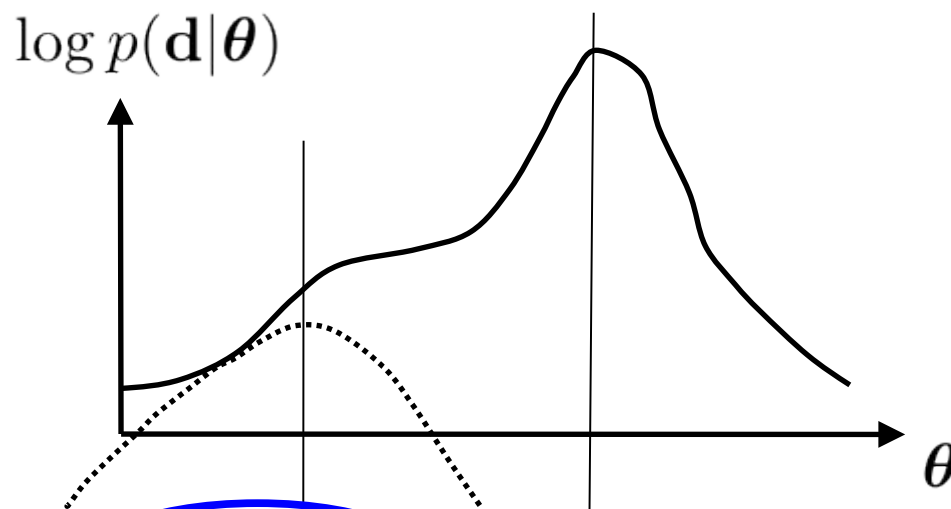
$$\sum_n \left[ \sum_k w_k^n \log \left( \frac{\mathcal{N}(d_n | \mu_k, \sigma_k^2) \pi_k}{w_k^n} \right) \right] = -\frac{1}{2} \sum_k \left[ \frac{1}{\sigma_k^2} \sum_n w_k^n (d_n - \mu_k)^2 + \left( \sum_n w_k^n \right) \log \sigma_k^2 \right] \\ + \sum_k \left[ \left( \sum_n w_k^n \right) \log \pi_k \right] + C$$



# Maximizing the lower bound

Lower bound:

$$\sum_n \left[ \sum_k w_k^n \log \left( \frac{\mathcal{N}(d_n | \mu_k, \sigma_k^2) \pi_k}{w_k^n} \right) \right] = -\frac{1}{2} \sum_k \left[ \frac{1}{\sigma_k^2} \sum_n w_k^n (d_n - \mu_k)^2 + \left( \sum_n w_k^n \right) \log \sigma_k^2 \right] + \sum_k \left[ \left( \sum_n w_k^n \right) \log \pi_k \right] + C$$



1. What is  $\tilde{\mu}_k$ ?

2. What is  $\tilde{\sigma}_k^2$ ?

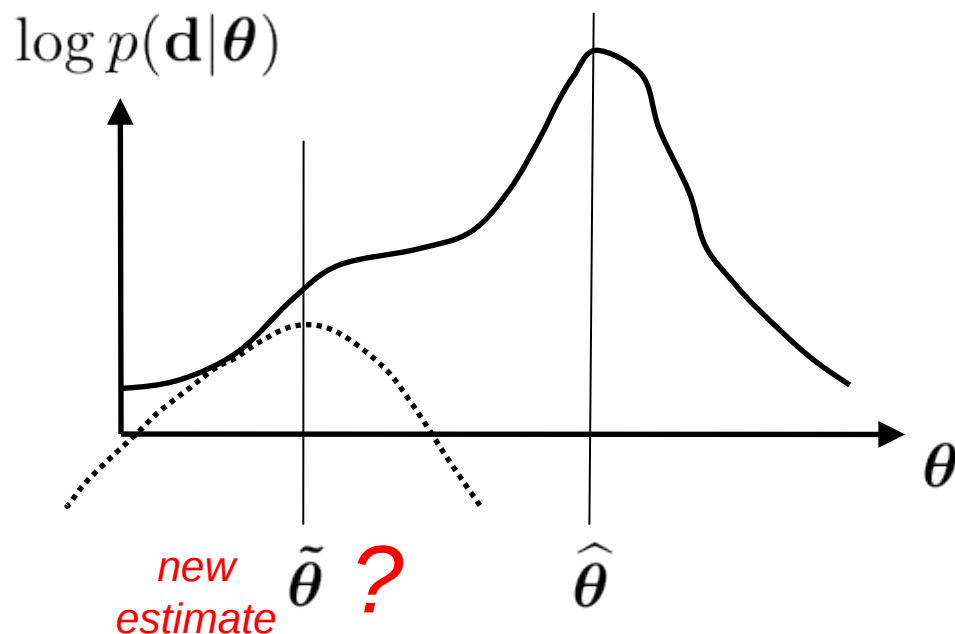
3. What is  $\tilde{\pi}_k$ ?



# Maximizing the lower bound

Lower bound:

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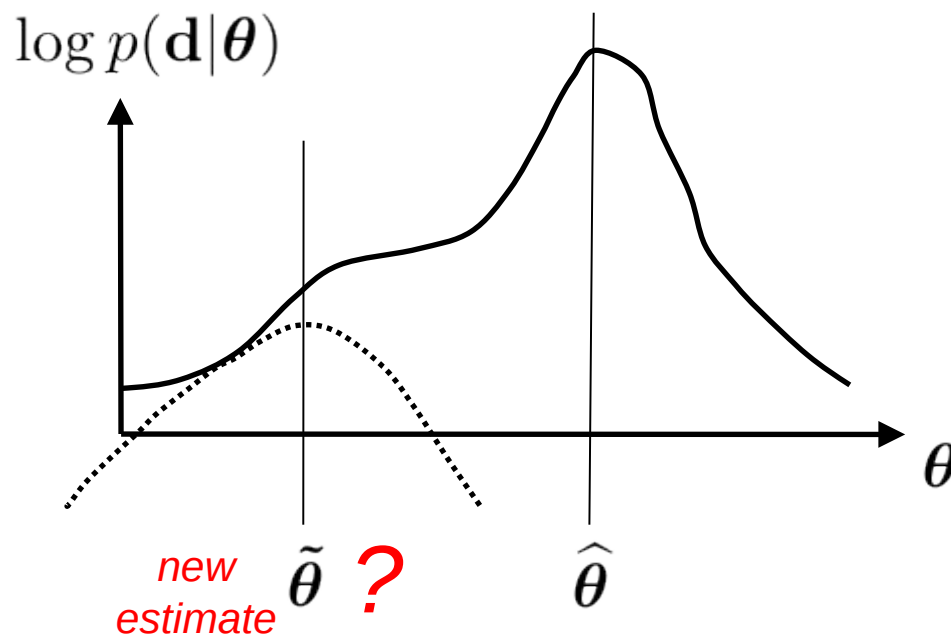


$$\frac{\partial}{\partial \theta} = 0$$

# Maximizing the lower bound

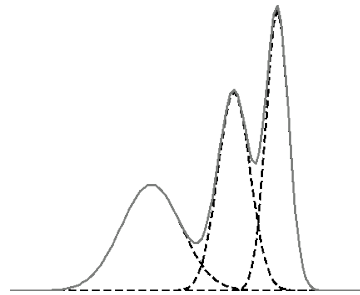
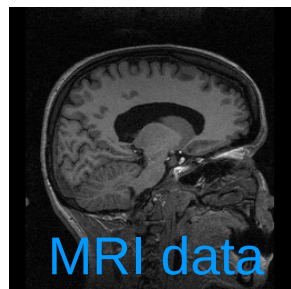
Lower bound:

$$\sum_n \left[ \sum_k w_k^n \log \left( \frac{\mathcal{N}(d_n | \mu_k, \sigma_k^2) \pi_k}{w_k^n} \right) \right] = -\frac{1}{2} \sum_k \left[ \frac{1}{\sigma_k^2} \sum_n w_k^n (d_n - \mu_k)^2 + \left( \sum_n w_k^n \right) \log \sigma_k^2 \right] \\ + \sum_k \left[ \left( \sum_n w_k^n \right) \log \pi_k \right] + C$$



$$\Rightarrow \begin{aligned} \tilde{\mu}_k &\leftarrow \frac{\sum_n w_k^n d_n}{\sum_n w_k^n} \\ \tilde{\sigma}_k^2 &\leftarrow \frac{\sum_n w_k^n (d_n - \tilde{\mu}_k)^2}{\sum_n w_k^n} \\ \tilde{\pi}_k &\leftarrow \frac{\sum_n w_k^n}{N} \end{aligned}$$

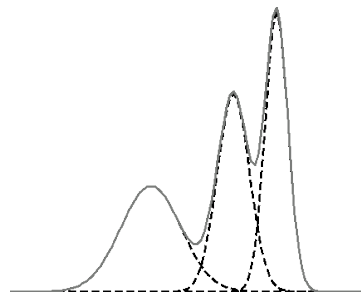
# Parameter optimizer summarized



Classify the image voxels  
according to the current  
parameter estimate  
("E-step")



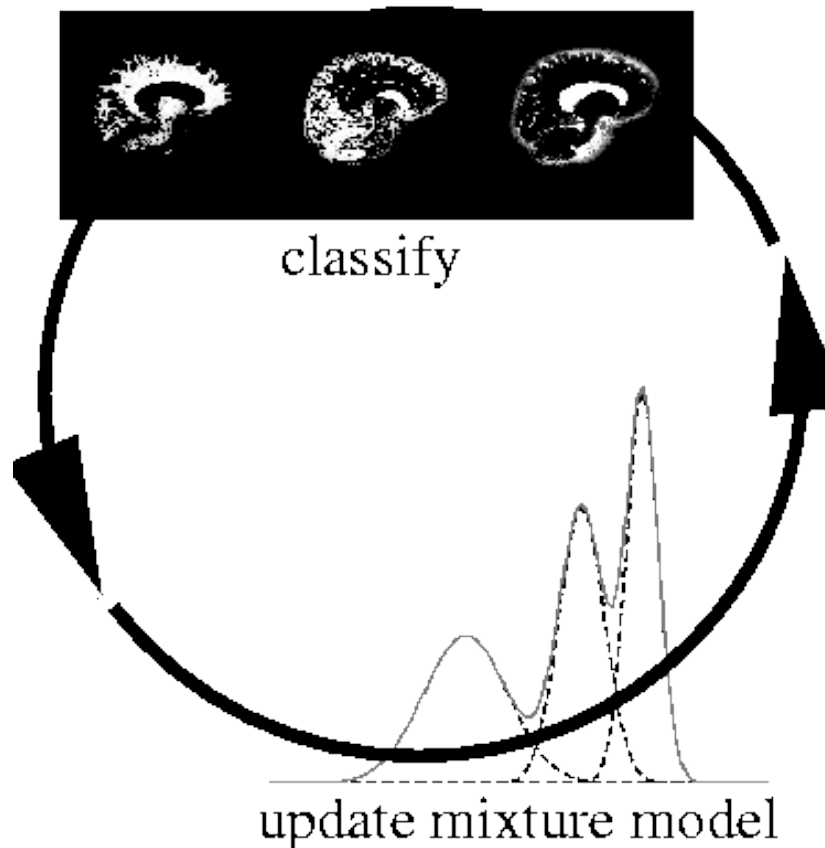
# Parameter optimizer summarized



Update the parameter estimate based on the current classification  
("M-step")

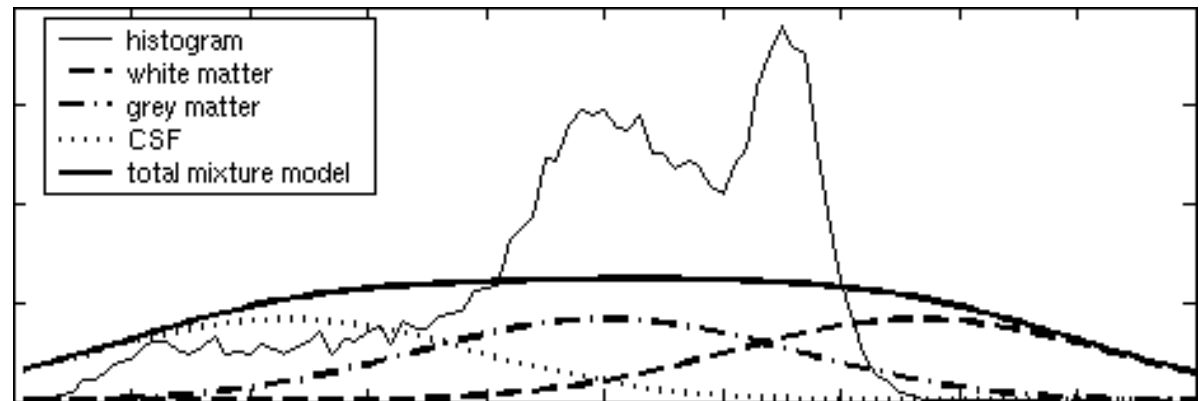
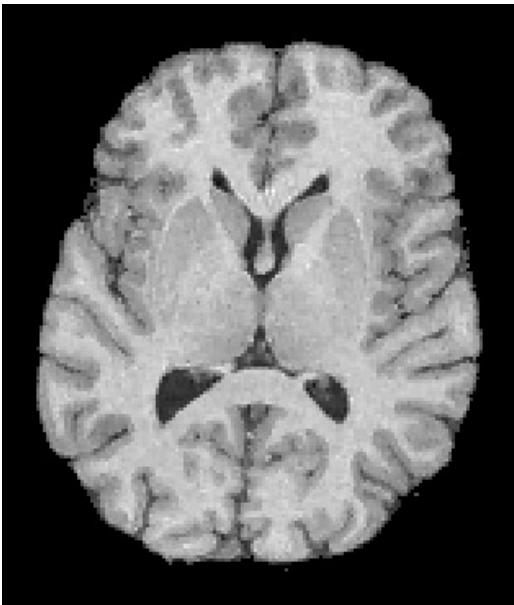


# Parameter optimizer summarized



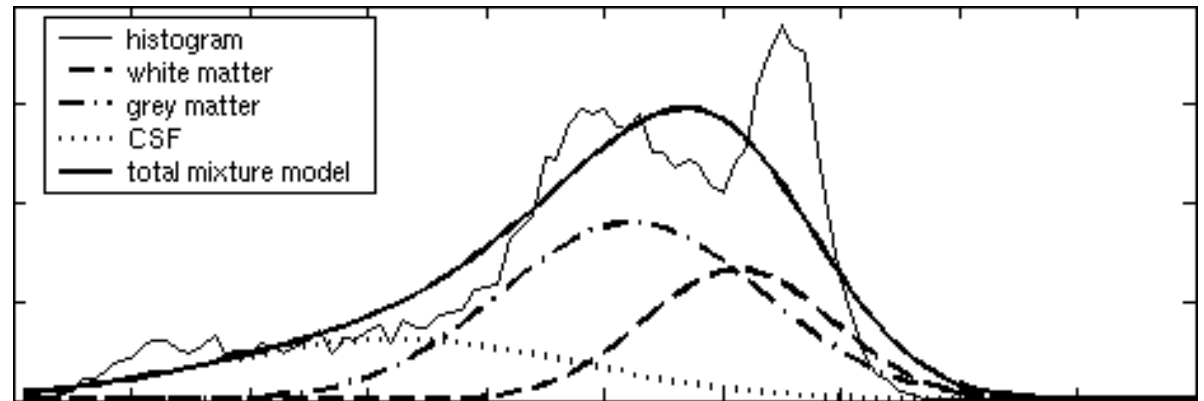
- Repeatedly apply closed-form parameter updates
- Each iteration improves the log likelihood

# Example



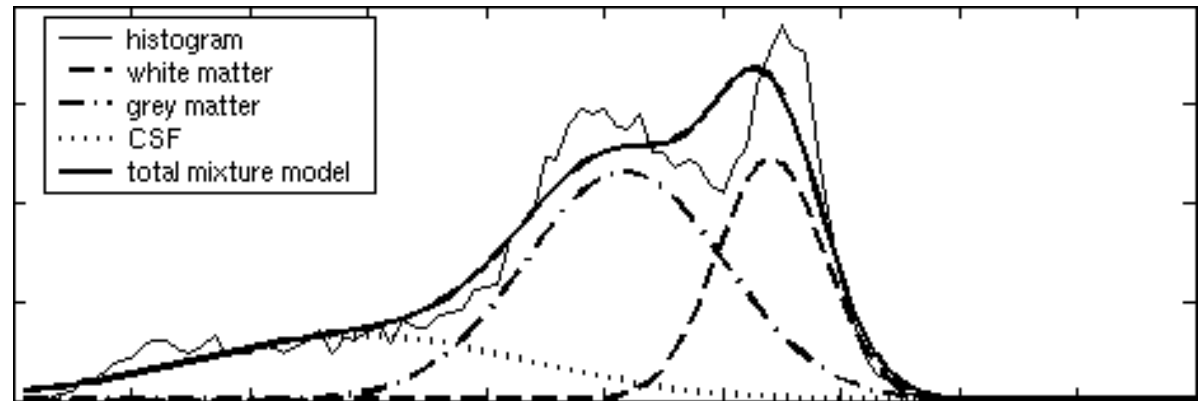
initialization

# Example



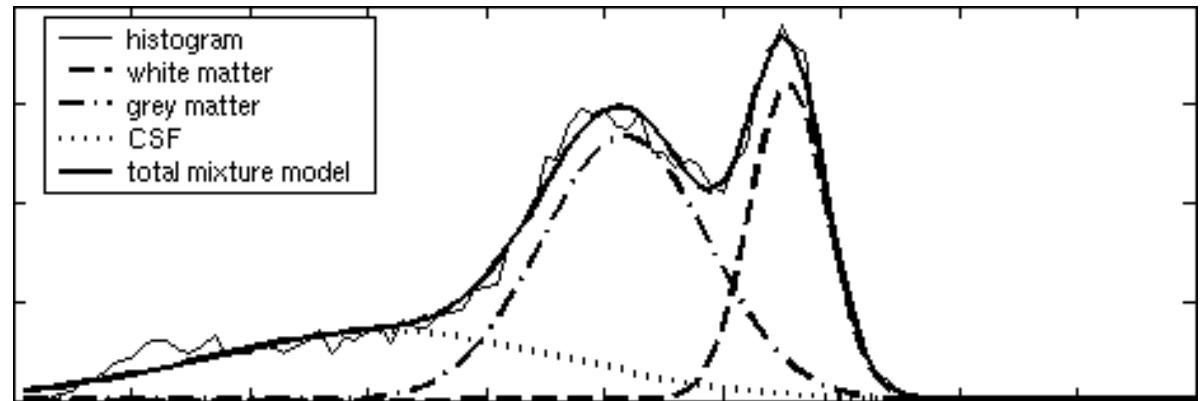
after one iteration

# Example



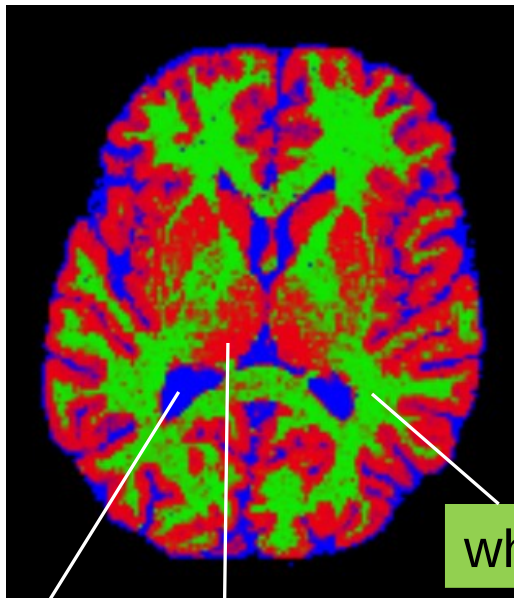
after 10 iterations

# Example



after 30 iterations

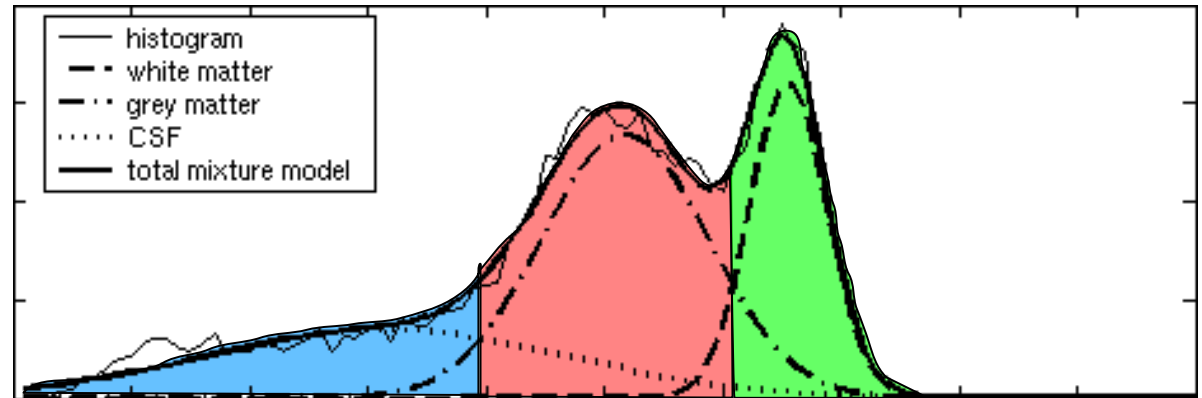
# Example



white matter

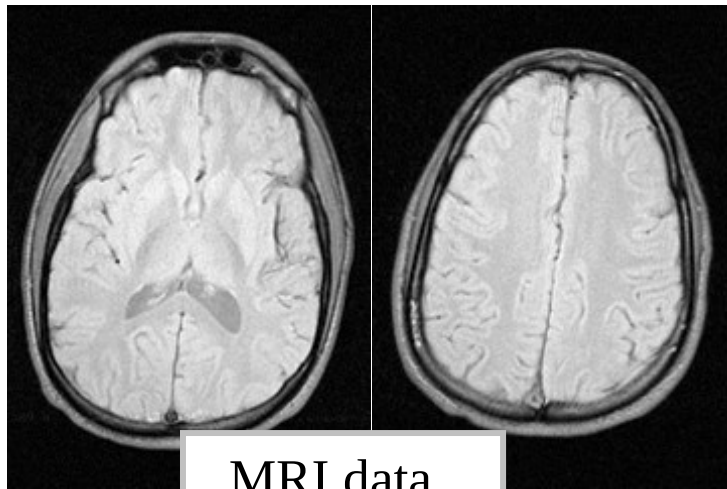
CSF

gray matter

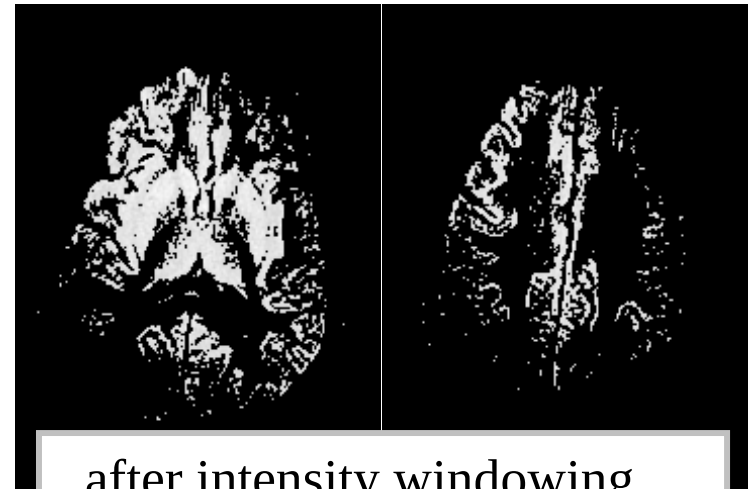


# MRI “bias field” artifact

- Imaging artifact in MRI
- Smooth intensity variations across the image area



MRI data



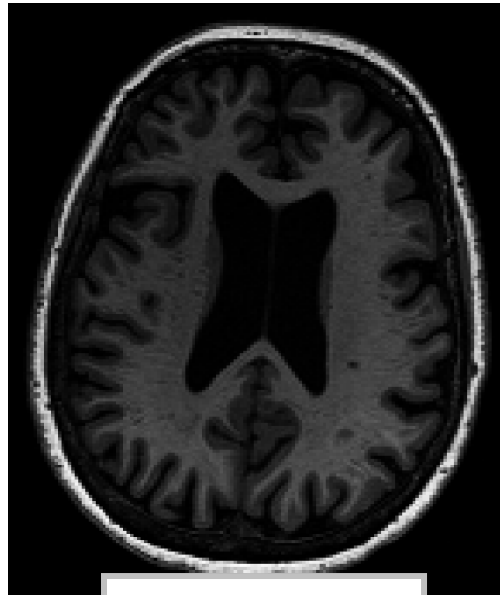
after intensity windowing...

# MRI “bias field” artifact

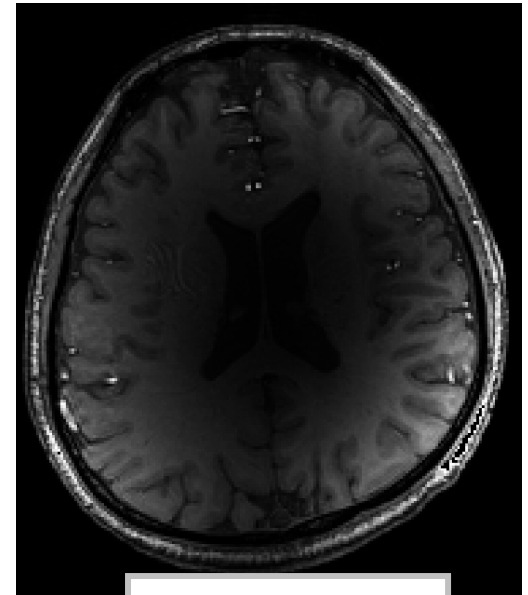
- Depends on the object being scanned
- Is much worse on the newest generation scanners



1.5 Tesla  
scanner



3 Tesla  
scanner

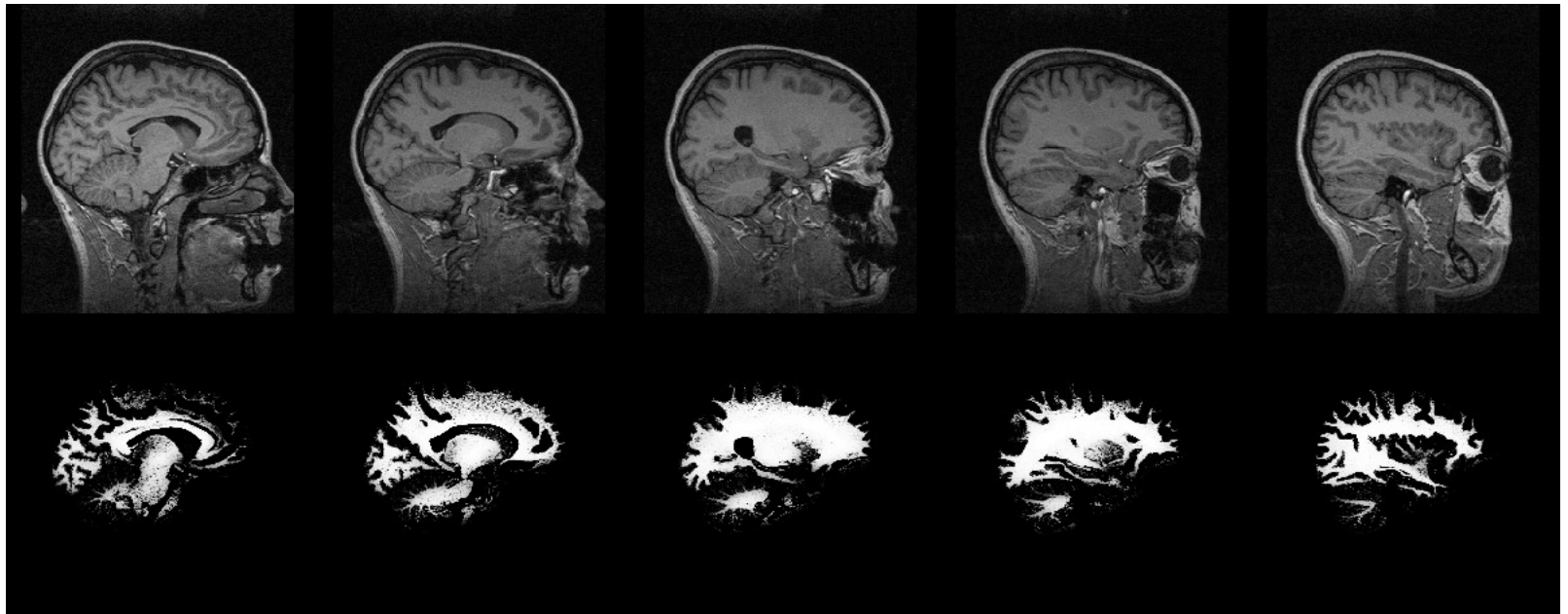


7 Tesla  
scanner



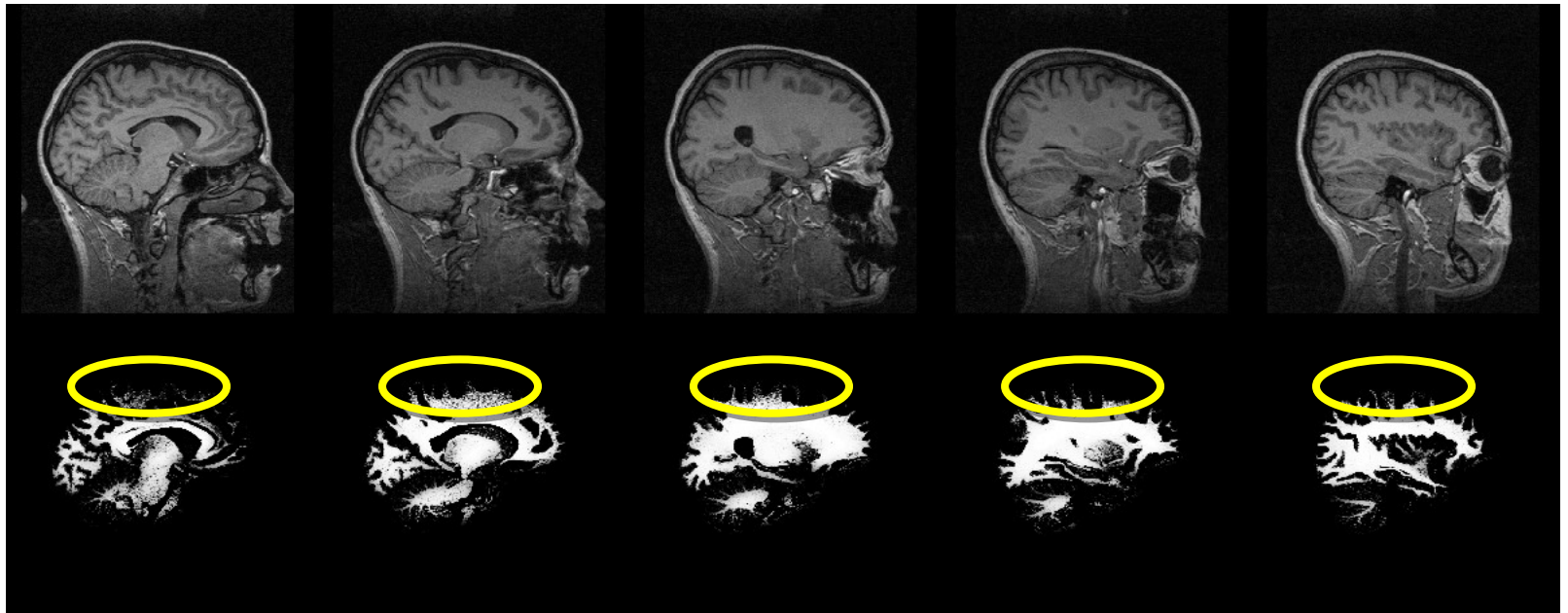
# MRI “bias field” artifact

Causes segmentation errors with our segmentation procedure so far...

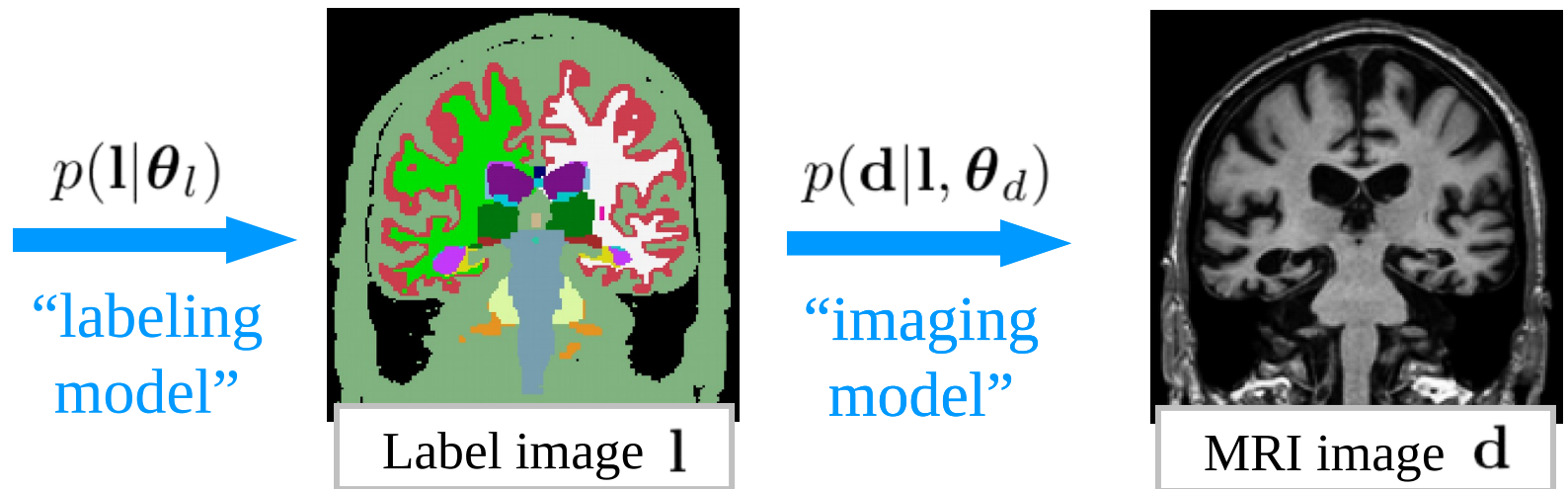


# MRI “bias field” artifact

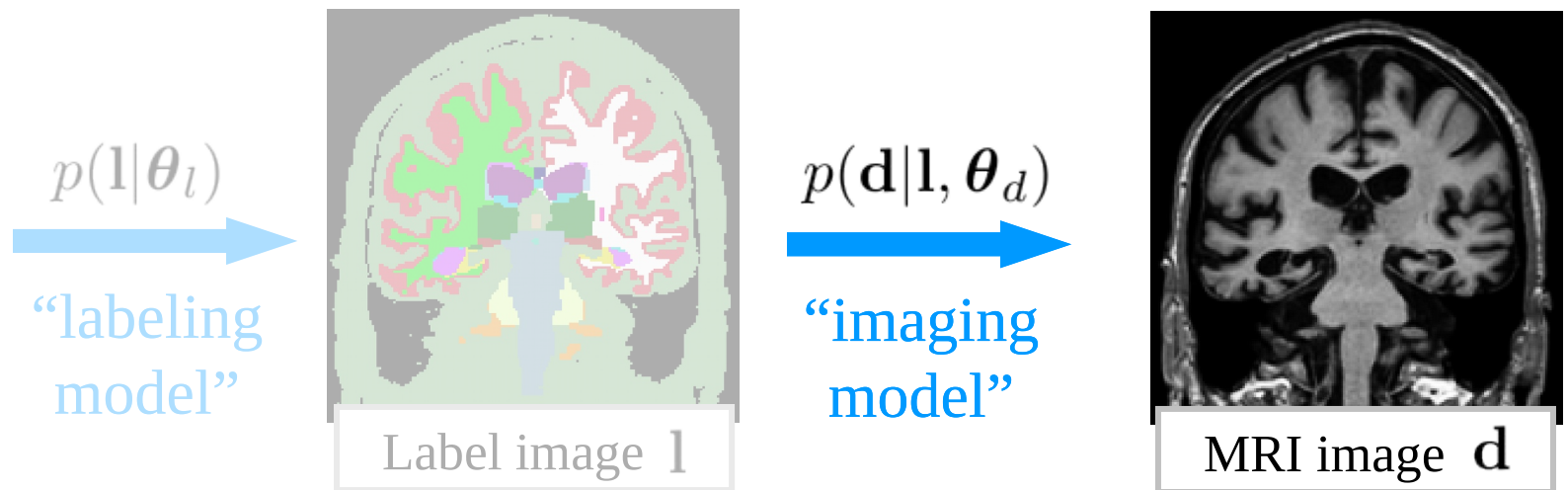
Causes segmentation errors with our segmentation procedure so far...



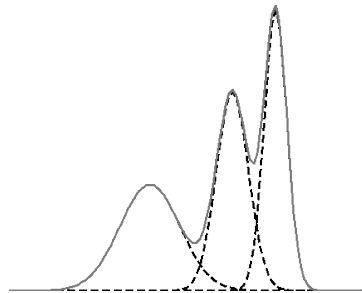
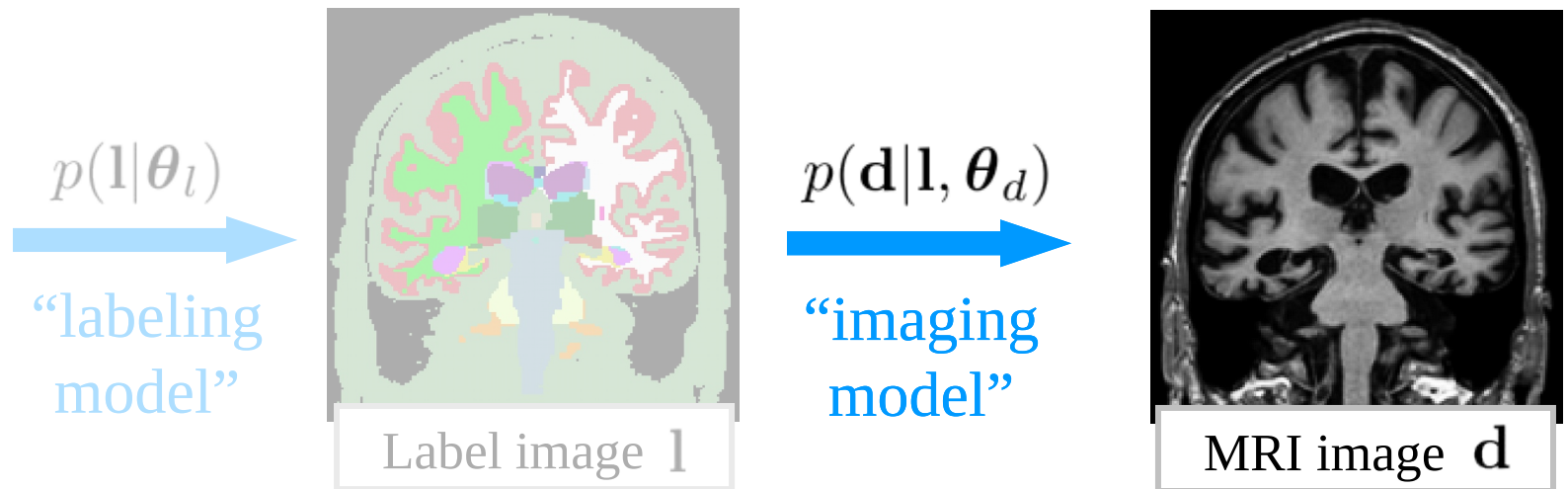
# Generative model



# Improved imaging model

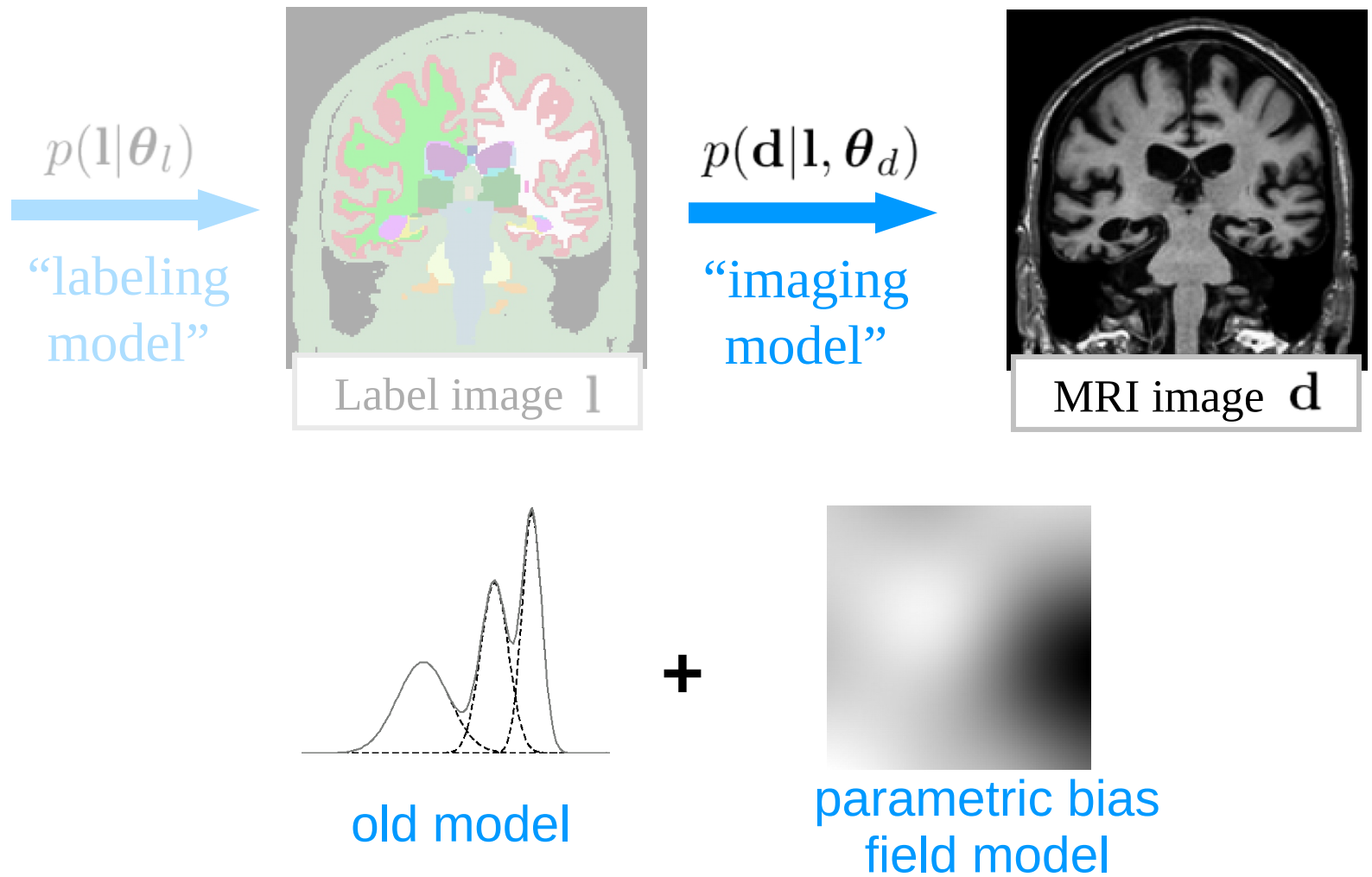


# Improved imaging model



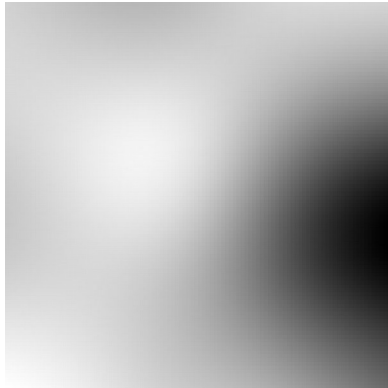
old model

# Improved imaging model



# Bias field model

Linear combination of  $M$  smooth basis functions



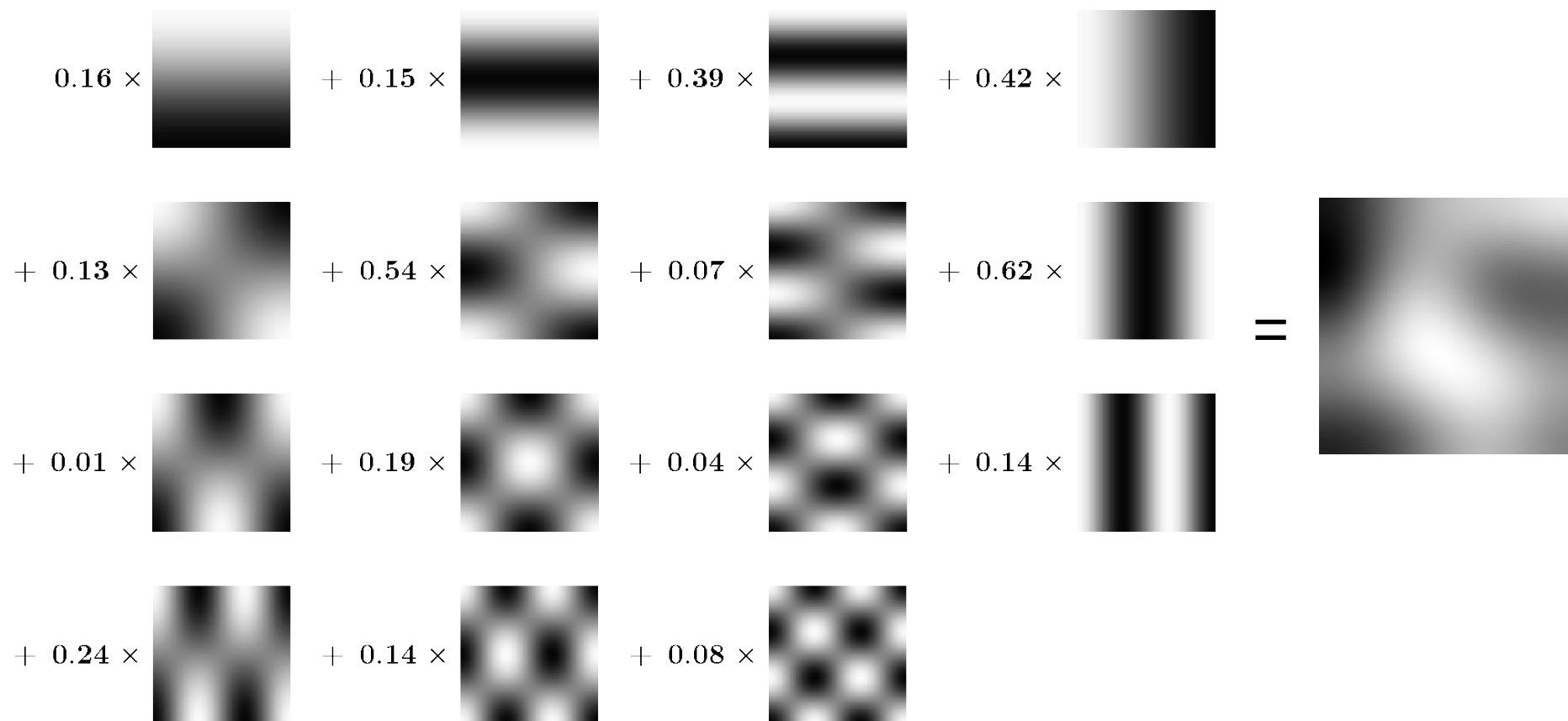
$$b_n = \sum_{m=1}^M c_m \phi_m^n$$

$$\mathbf{b} = (b_1, \dots, b_N)^T$$

$\phi_m^n$ : value of the  $m$ th basis function in voxel  $n$

$\mathbf{c} = (c_1, \dots, c_M)^T$ : parameters of the bias field model

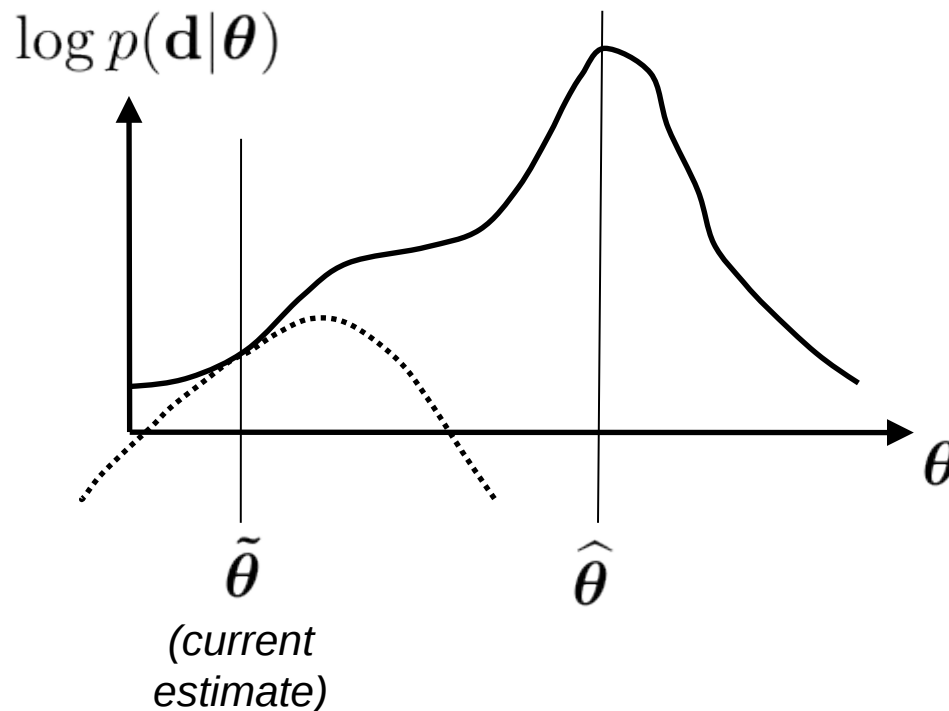
# Bias field model





# Parameter optimization

- Bias field parameters are part of the model parameters
- Parameter optimization with a **Generalized** Expectation Maximization (GEM) algorithm

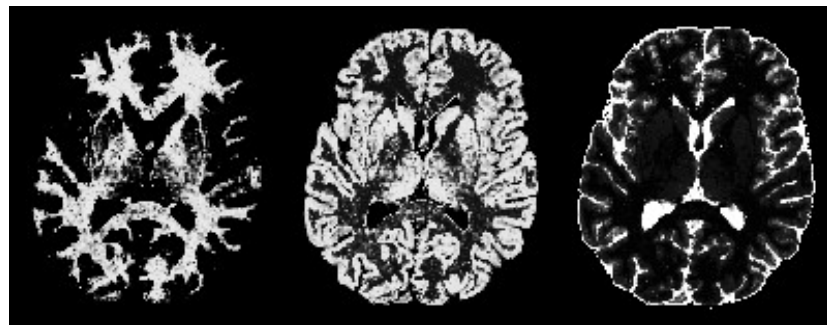
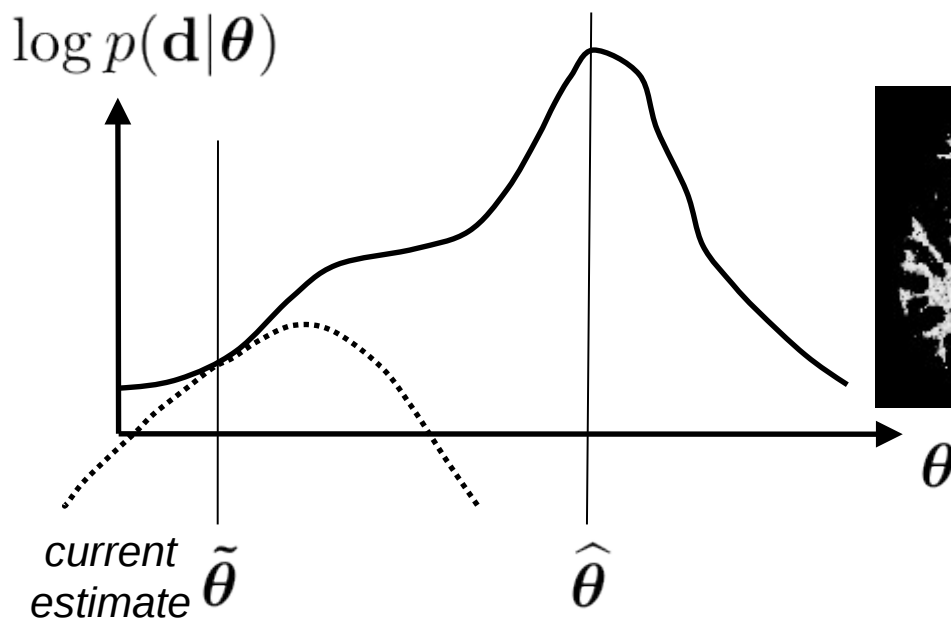


- Repeatedly **improve** a lower bound to the log likelihood function
- Still guaranteed to **never** move in a wrong direction!

# Constructing the lower bound

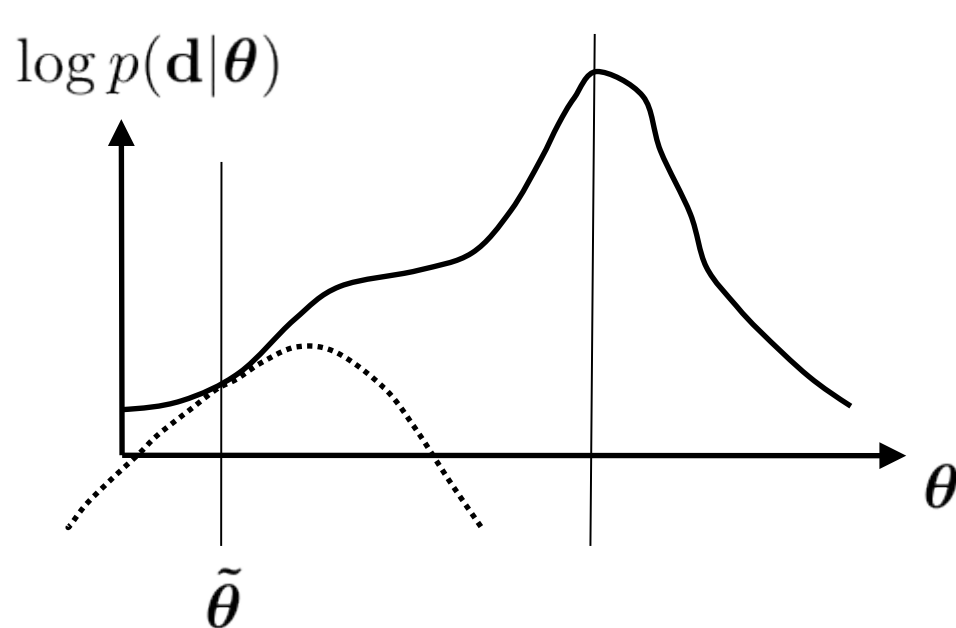
- Same derivations as before
- The lower bound touches the objective function at current parameter estimate if

$$w_k^n \propto \mathcal{N}\left(d_n - \sum_m \tilde{c}_m \phi_m^n \mid \tilde{\mu}_k, \tilde{\sigma}_k^2\right) \tilde{\pi}_k$$



# Improving the lower bound

$$\frac{\partial}{\partial \theta} = 0 \quad \Rightarrow \quad \tilde{\mu}_k \leftarrow \frac{\sum_n w_k^n (d_n - \sum_m \tilde{c}_m \phi_m^n)}{\sum_n w_k^n}$$
$$\tilde{\sigma}_k^2 \leftarrow \frac{\sum_n w_k^n (d_n - \sum_m \tilde{c}_m \phi_m^n - \tilde{\mu}_k)^2}{\sum_n w_k^n}$$



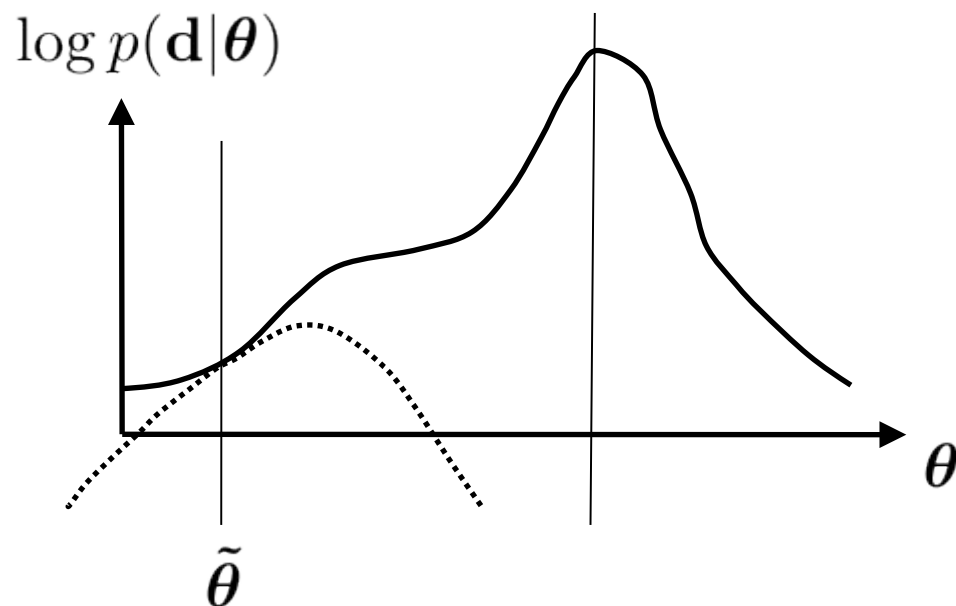
$$\tilde{\pi}_k \leftarrow \frac{\sum_n w_k^n}{N}$$

# Improving the lower bound

$$\frac{\partial}{\partial \theta} = 0 \quad \Rightarrow \quad \tilde{\mu}_k \leftarrow \frac{\sum_n w_k^n (d_n - \sum_m \tilde{c}_m \phi_m^n)}{\sum_n w_k^n}$$

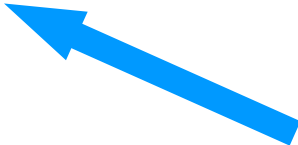
$$\tilde{\sigma}_k^2 \leftarrow \frac{\sum_n w_k^n (d_n - \sum_m \tilde{c}_m \phi_m^n - \tilde{\mu}_k)^2}{\sum_n w_k^n}$$

$$\tilde{\pi}_k \leftarrow \frac{\sum_n w_k^n}{N}$$



# Improving the lower bound (cont.)

$$\tilde{\mathbf{c}} \leftarrow (\Phi^T \mathbf{S} \Phi)^{-1} \Phi^T \mathbf{S} \mathbf{r}$$

- 
- ✓ cf. linear basis function regression
  - ✓ smoothing operation

$$\Phi = \begin{pmatrix} \phi_1^1 & \phi_2^1 & \cdots & \phi_M^1 \\ \phi_1^2 & \phi_2^2 & \cdots & \phi_M^2 \\ \vdots & \vdots & \ddots & \vdots \\ \phi_1^N & \phi_2^N & \cdots & \phi_M^N \end{pmatrix}$$

$$s_k^n = \frac{w_k^n}{\tilde{\sigma}_k^2}, \quad s_n = \sum_k s_k^n, \quad \mathbf{S} = \text{diag}(s_n), \quad \tilde{d}_n = \frac{\sum_k s_k^n \tilde{\mu}_k}{\sum_k s_k^n}, \quad \mathbf{r} = \begin{pmatrix} d_1 - \tilde{d}_1 \\ \vdots \\ d_N - \tilde{d}_N \end{pmatrix}$$

# Improving the lower bound (cont.)

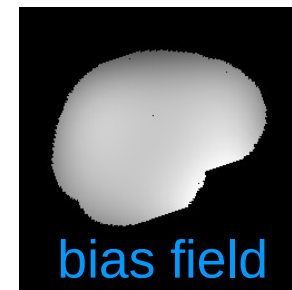
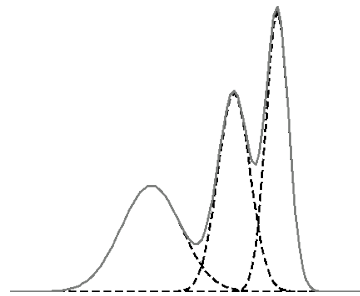
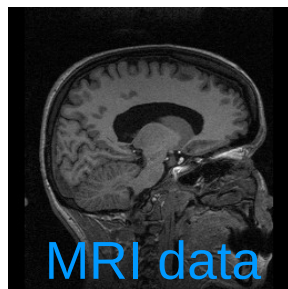
$$\tilde{\mathbf{c}} \leftarrow (\Phi^T \mathbf{S} \Phi)^{-1} \Phi^T \mathbf{S} \mathbf{r}$$

- ✓ cf. linear basis function regression
- ✓ smoothing operation

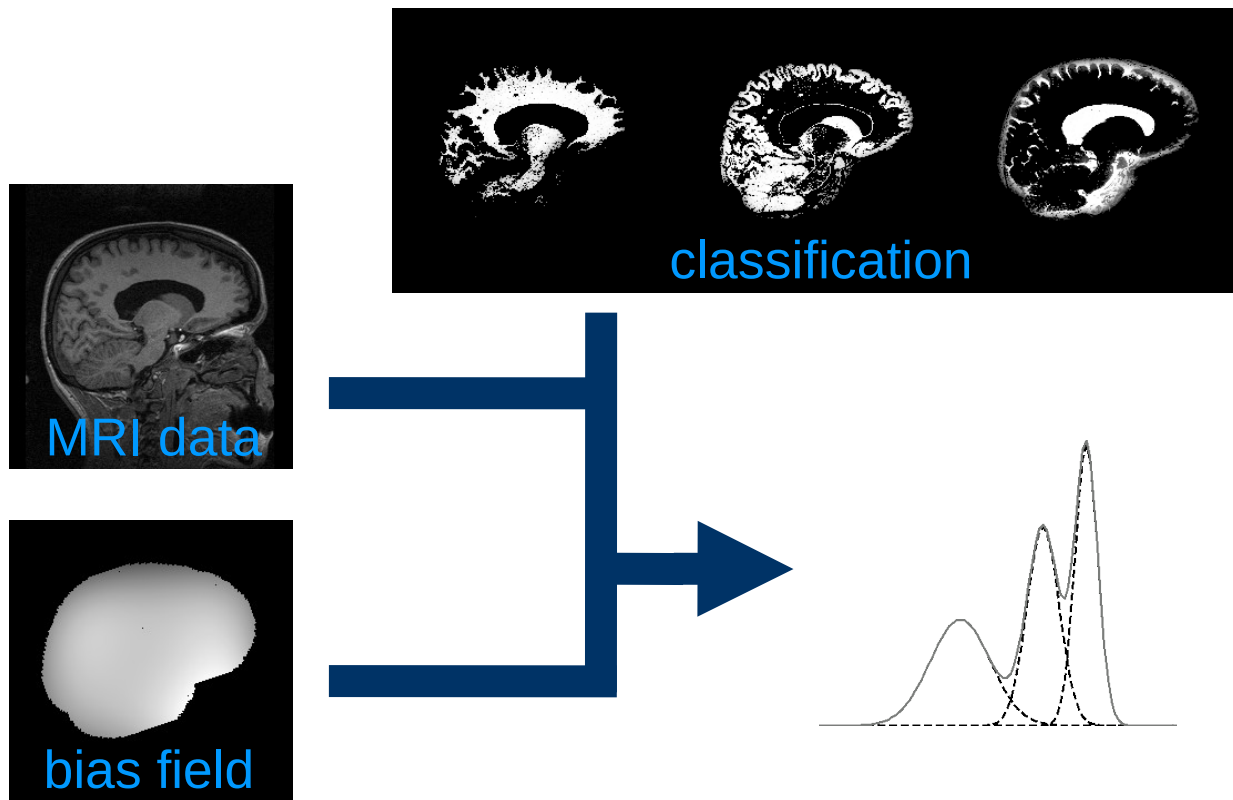
$$\Phi = \begin{pmatrix} \phi_1^1 & \phi_2^1 & \dots & \phi_M^1 \\ \phi_1^2 & \phi_2^2 & \dots & \phi_M^2 \\ \vdots & \vdots & \ddots & \vdots \\ \phi_1^N & \phi_2^N & \dots & \phi_M^N \end{pmatrix}$$

$$s_k^n = \frac{w_k^n}{\tilde{\sigma}_k^2}, \quad s_n = \sum_k s_k^n, \quad \mathbf{S} = \text{diag}(s_n), \quad \tilde{d}_n = \frac{\sum_k s_k^n \tilde{\mu}_k}{\sum_k s_k^n}, \quad \mathbf{r} = \begin{pmatrix} d_1 - \tilde{d}_1 \\ \vdots \\ d_N - \tilde{d}_N \end{pmatrix}$$

# E-step

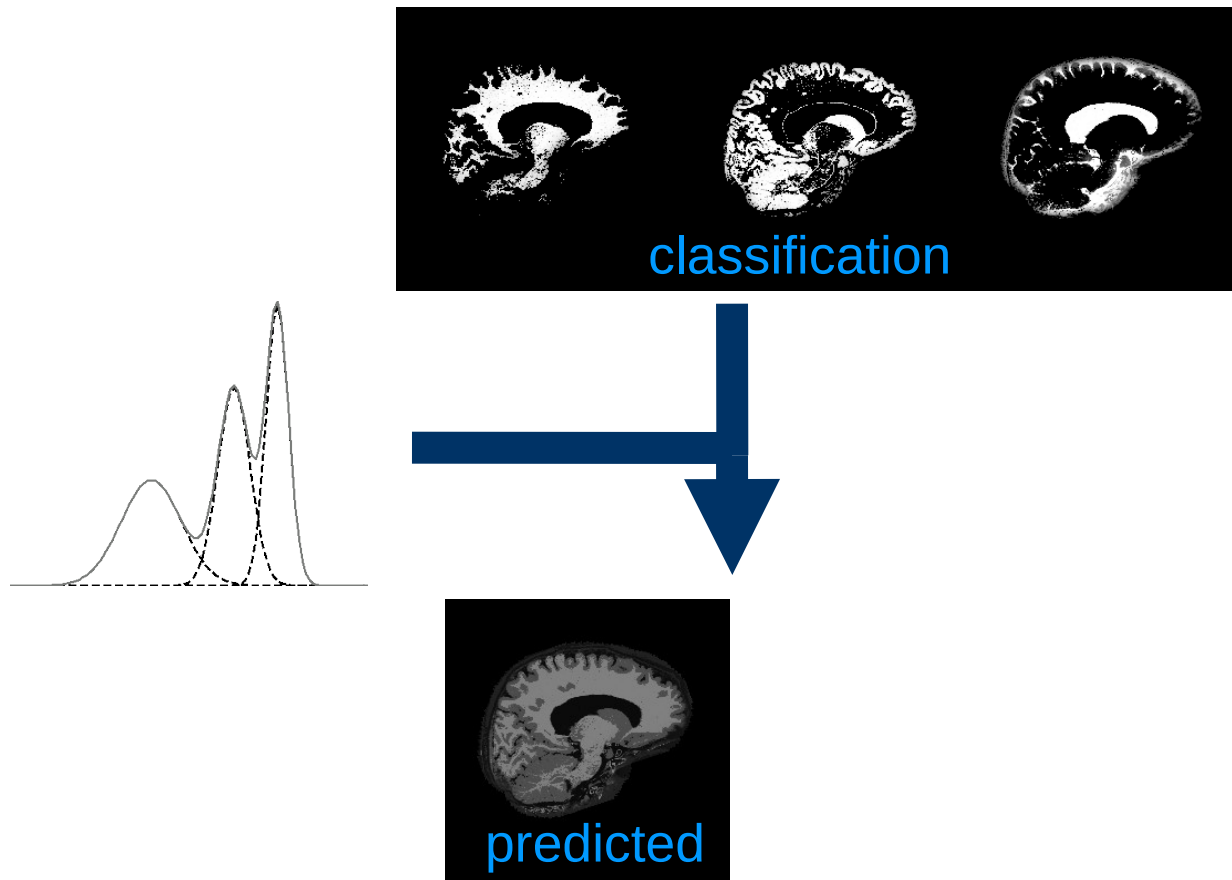


# M-step part 1: distribution estimation

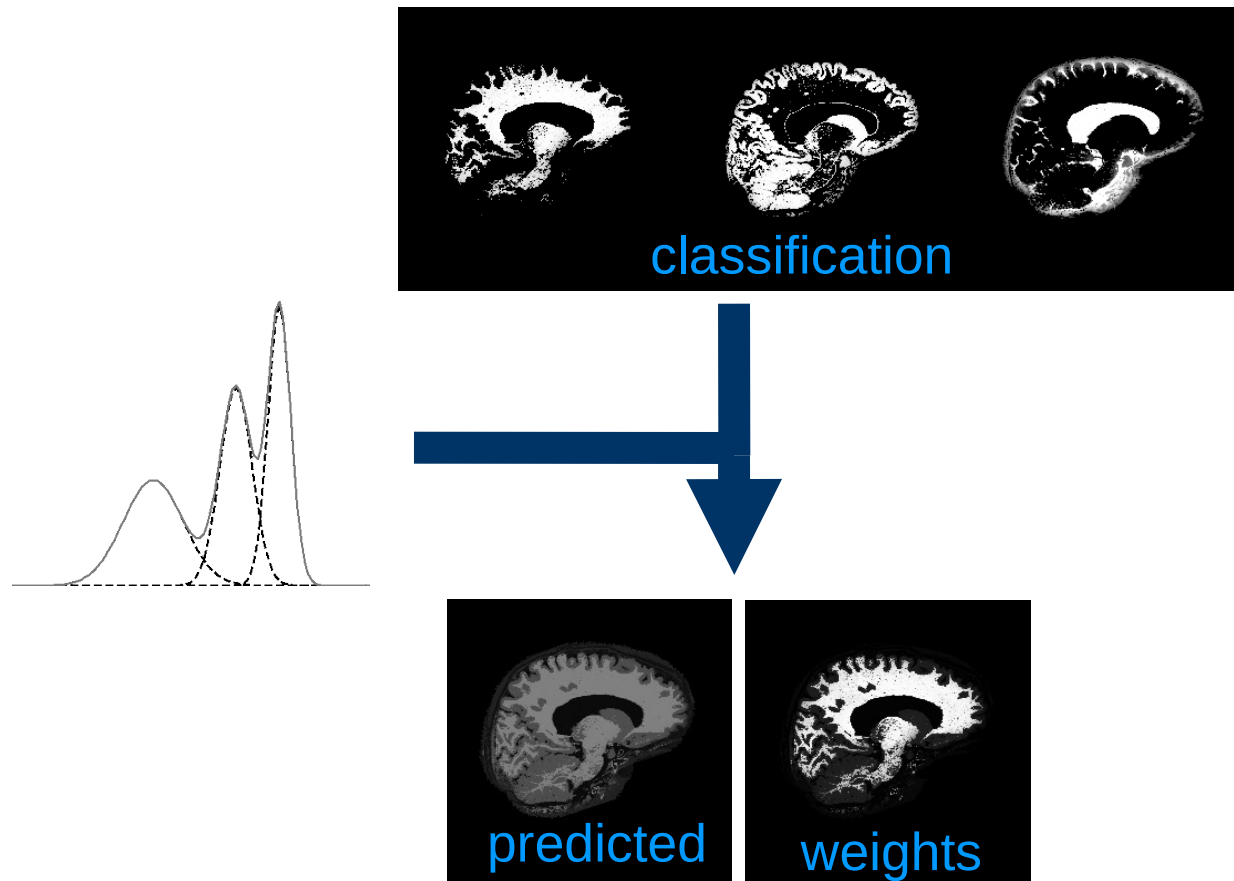




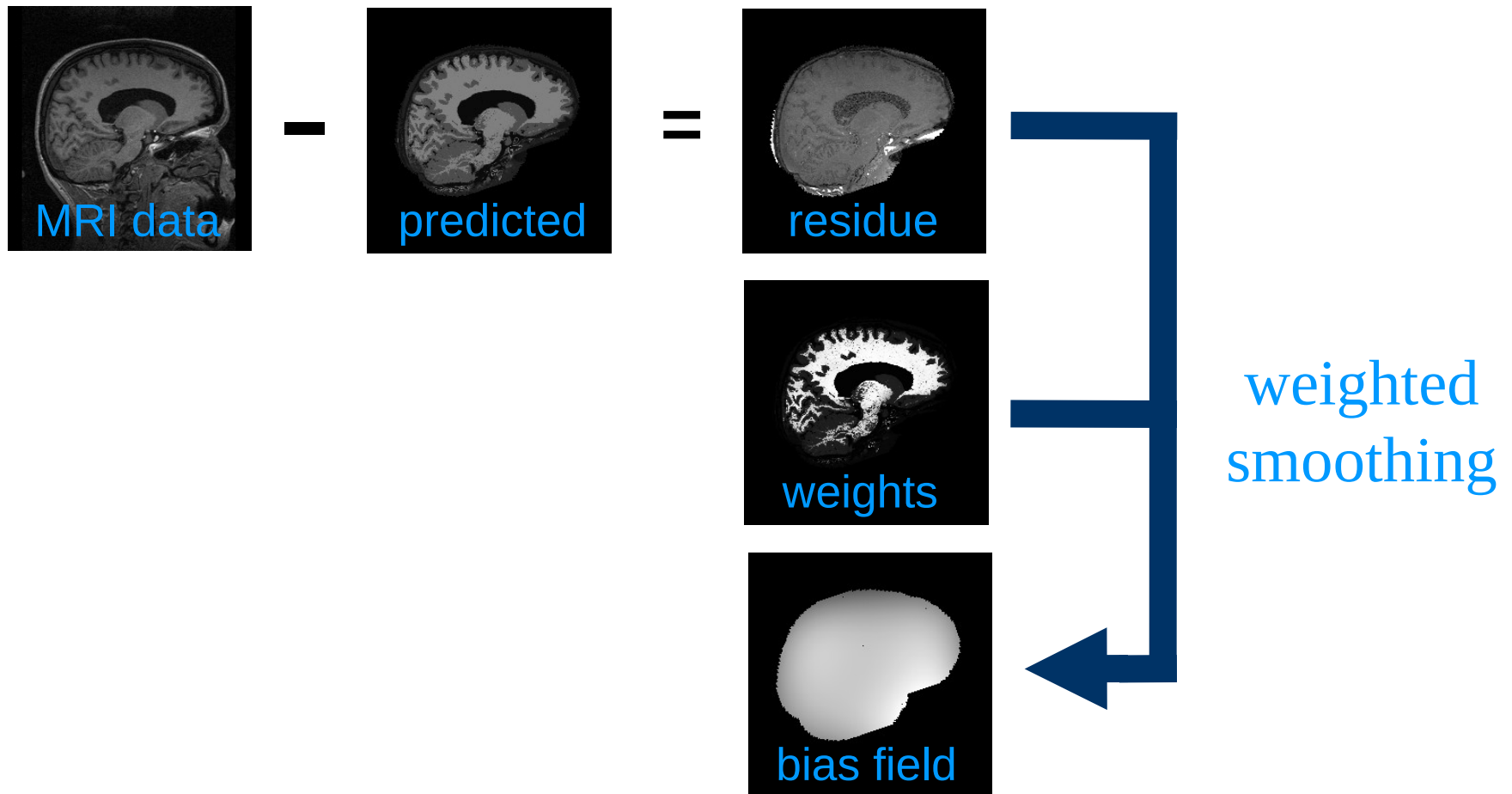
# M-step part 2: bias field estimation



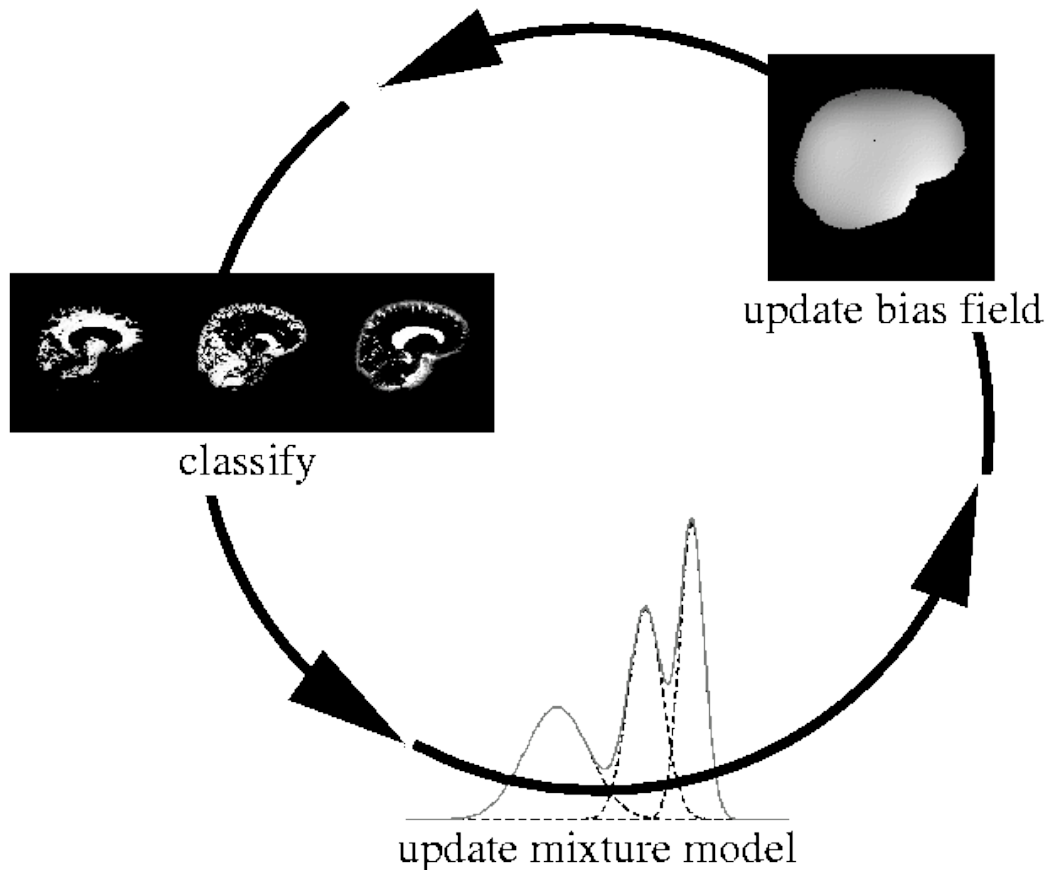
# M-step part 2: bias field estimation



# M-step part 2: bias field estimation

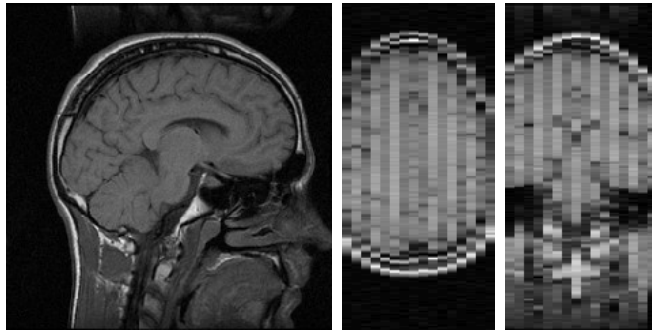


# Parameter optimizer summarized

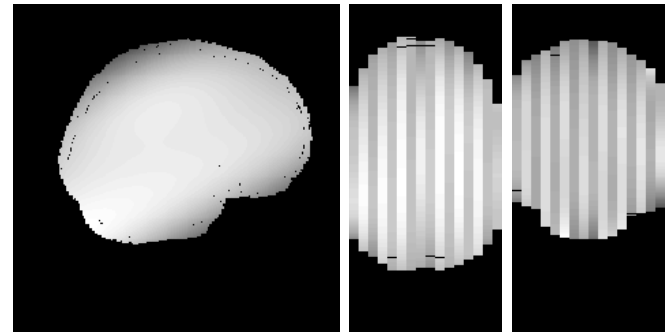


- Repeatedly apply closed-form parameter updates
- Each iteration improves the likelihood

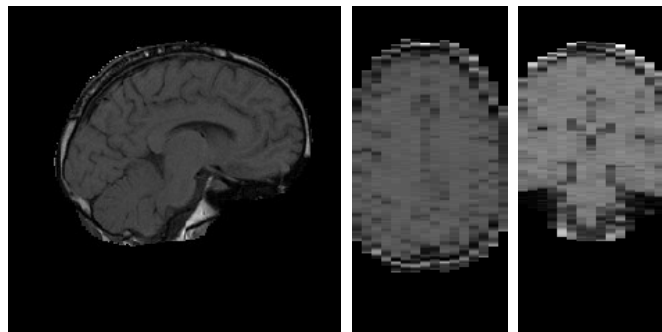
# Example



MRI data



Estimated bias field



Bias-corrected MRI data

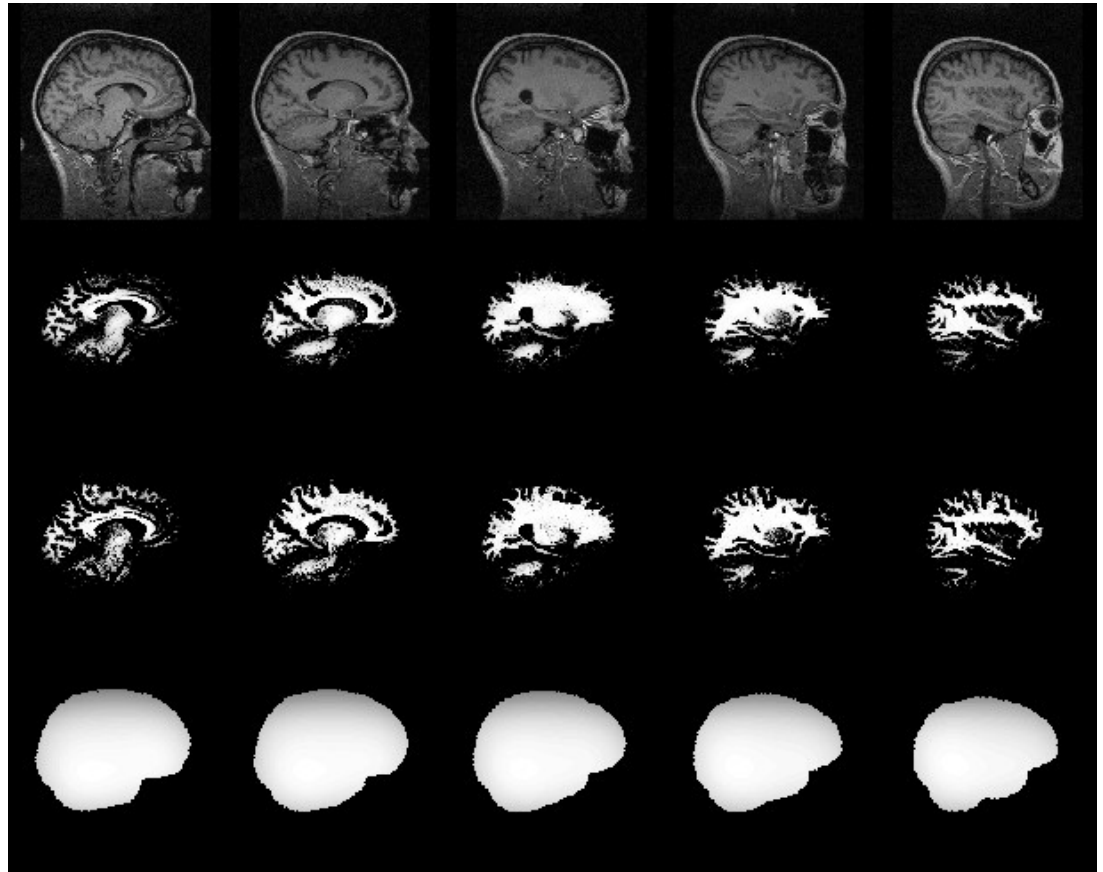
# Example

MRI data

White matter without  
bias field model

White matter with  
bias field model

Estimated bias field



# Example

MRI data

White matter without  
bias field model

White matter with  
bias field model

Estimated bias field

